



## Bluetooth® Low Energy 5.4 certified network coprocessor



WLCSP36 (2.652 mm x 2.592 mm)



VFQFPN32 (5 x 5 mm)

| Product status |                            |  |  |  |
|----------------|----------------------------|--|--|--|
| STM32WB05xN    | STM32WB05KN<br>STM32WB05TN |  |  |  |

#### **Features**

Includes ST state-of-the-art patented technology.

Bluetooth® Low Energy network coprocessor supporting the Bluetooth 5.4 specifications

- 2 Mbps data rate
- Long range (Coded PHY)
- Advertising extensions
- Direction finding (AoA/AoD)
- LE ping procedure
- Periodic advertising and periodic advertising sync transfer

#### Radio

- RX sensitivity level: -97 dBm @ 1 Mbps, -104 dBm @ 125 kbps (long range)
- Programmable output power up to +8 dBm (at antenna connector)
- Data rate supported: 2 Mbps, 1 Mbps, 500 kbps and 125 kbps
- Integrated balun
- Support for external PA and LNA
- Available integrated passive device (IPD) companion chip for optimized matching and filtering

#### Ultra-low-power radio performance

- 8 nA in Shutdown mode (1.8 V)
- 0.8  $\mu$ A in Deepstop mode (with external LSE and Bluetooth LE wake-up sources, 1.8 V)
- 1.0  $\mu$ A in Deepstop mode (with internal LSI and Bluetooth LE wake-up sources, 1.8 V)
- 4.3 mA peak current in TX (@ 0 dBm, 3.3 V)
- 3.4 mA peak current in RX (@ sensitivity level, 3.3 V)

High performance and ultra-low-power Arm<sup>®</sup> Cortex<sup>®</sup>-M0+ 32-bit, running up to 64 MHz

Dynamic current consumption: 14 µA/MHz

Operating supply voltage: from 1.7 to 3.6 V

-40 °C to 105 °C temperature range

## Supply and reset management

- High efficiency embedded SMPS step-down converter with intelligent bypass mode
- Ultra-low-power power-on-reset (POR) and power-down-reset (PDR)
- Programmable voltage detector (PVD)

### **Clock sources**

• 64 MHz PLL



- Fail safe 32 MHz crystal oscillator with integrated trimming capacitors
- 32 kHz crystal oscillator
- Internal low-power 32 kHz RO

## System peripherals

- 1x DMA controller with 8 channels supporting SPI-I2S, USART
- 1x SPI
- 1x USART

## Up to 20 fast I/Os

- All of them with wake-up capability
- All of them retain state in low-power
- All of them 5 V tolerant

## **Development support**

Serial wire debug (SWD)

## All packages are ECOPACK2 compliant.

## **Applications**

- Industrial
- Home and industrial automation
- Asset tracking, ID location, real-time locating system
- Smart lighting
- Fitness, wellness and sports
- Healthcare, consumer medical
- Security/proximity
- Remote control
- Assisted living
- Mobile phone peripherals
- PC peripherals

DS14620 - Rev 2 page 2/52



# 1 Introduction

This document provides the ordering information and mechanical device characteristics of the STM32WB05xN microcontrollers, based on Arm<sup>®</sup> core.

For information on the Arm<sup>®</sup> Cortex<sup>®</sup>-M0+ core, refer to the Cortex<sup>®</sup>-M0+ technical reference manual, available from the www.arm.com website.

For information on Bluetooth® refer to www.bluetooth.com website.

Note: Arm is a registered trademark of Arm Limited (or its subsidiaries) in the US and/or elsewhere.





DS14620 - Rev 2 page 3/52



# 2 Description

The STM32WB05xN is an ultra-low-power Bluetooth<sup>®</sup> Low Energy wireless network coprocessor addressing standard Bluetooth<sup>®</sup> LE protocol. Interface with external micro controller can be achieved through SPI and USART. It embeds STMicroelectronics's state-of-the-art 2.4 GHz radio IPs, optimized for ultra-low-power consumption and excellent radio performance, for unparalleled battery lifetime. It is compliant with Bluetooth Low Energy SIG core specification version 5.4.

The STM32WB05xN embeds a Arm<sup>®</sup> Cortex<sup>®</sup>-M0+ microcontroller that can operate up to 64 MHz and also the BlueNRG core co-processor (DMA based) for Bluetooth Low Energy timing critical operations.

The STM32WB05xN features standard and advanced communication interfaces:

- 1x SPI
- 1x USART

The STM32WB05xN operates in the -40 to +105 °C temperature range from a 1.7 V to 3.6 V power supply. A comprehensive set of power-saving modes enables the design of low-power applications.

The STM32WB05xN integrates a high efficiency SMPS step-down converter and an integrated PDR circuitry with a fixed threshold that generates a device reset when the  $V_{DD}$  drops under 1.65 V.

The STM32WB05xN comes in different package versions supporting up to:

- 20 I/Os for the VFQFPN32 package
- 20 I/Os for the WLCSP36 package

DS14620 - Rev 2 page 4/52



Table 1. STM32WB05xx device features and peripheral counts

|                          | STM32WB05KN                        | STM32WB05TN  |   |  |  |
|--------------------------|------------------------------------|--|---|--|--|
| Bluetooth Low Energy     |                                    | Y  | Yes   |  |  |
| Communication interfaces | SPI                                |  | 1   |  |  |
| Communication interfaces | USART                              |  | 1   |  |  |
| Wake-up pins             |                                    | 2  | 20  |  |  |
| GPIOs                    |                                    | 2  | 20  |  |  |
| Maximum CPU frequency    | 64 MHz                             |  |   |  |  |
| Operating temperature    | -40 °C to 105 °C temperature range |  |   |  |  |
| Operating voltage        |                                    | 1.7 to 3.6 V   |   |  |  |
|                          |                                    | VFQFPN32   | WLCSP36   |  |  |
| Package                  |                                    | 5 x 5 mm,<br>0.50 mm pitch,<br>very fine pitch<br>quad flat no lead<br>package | 2.652 x 2.592 mm,<br>0.40 mm pitch,<br>wafer level chip<br>scale array<br>package |  |  |

DS14620 - Rev 2 page 5/52



## 3 Functional overview

## 3.1 Arm Cortex-M0+ core with MPU

The STM32WB05xN contains an Arm Cortex-M0+ microcontroller core. The Arm Cortex-M0+ was developed to provide a low-cost platform that meets the needs of CPU implementation, with a reduced pin count and low-power consumption, while delivering outstanding computational performance and an advanced response to interrupts. The Arm Cortex-M0+ can run from 1 MHz up to 64 MHz.

The Arm Cortex-M0+ processor is built on a highly area and power optimized 32-bit processor core, with a 2-stage pipeline Von Neumann architecture. The processor delivers exceptional energy efficiency through a small but powerful instruction set and extensively optimized design, providing high-end processing hardware including a single-cycle multiplier.

The interrupts are handled by the Arm Cortex-M0+ Nested Vector Interrupt Controller (NVIC). The NVIC controls specific Arm Cortex-M0+ interrupts as well as the STM32WB05xN peripheral interrupts. With its embedded ARM core, the STM32WB05xN family is compatible with all Arm tools and software.

## 3.2 RF subsystem

The STM32WB05xN embeds an ultra-low-power radio, compliant with Bluetooth® Low Energy (Bluetooth® LE) specification. The Bluetooth® LE features 1 Mbps and 2 Mbps transfer rates as well as long range options (125 kbps, 500 kbps), supports multiple roles simultaneously acting at the same time as Bluetooth® Low Energy sensor and hub device.

The Bluetooth® LE protocol stack is implemented by an efficient system partitioned as follows:

- Hardware part: BlueCore handling time critical and time consuming Bluetooth<sup>®</sup> LE protocol parts
- Firmware part: Arm<sup>®</sup> Cortex-M0+ core handling non time critical Bluetooth<sup>®</sup> LE protocol parts

## 3.2.1 RF front-end block diagram

The RF front end is based on a direct modulation of the carrier in TX, and uses a low IF architecture in RX mode.

Thanks to an internal transformer with RF pins, the circuit directly interfaces the antenna (single ended connection, impedance close to  $50~\Omega$ ). The natural band pass behavior of the internal transformer simplifies outside circuitry aimed at harmonic filtering and out of band interferer rejection.

In transmit mode, the maximum output power is user selectable through the programmable LDO voltage of the power amplifier. A linearized, smoothed analog control offers a clean power ramp-up.

In receive mode the circuit can be used in standard high performance or in reduced power consumption (user programmable). The automatic gain control (AGC) is able to reduce the chain gain at both RF and IF locations, for an optimized interferer rejection. Thanks to the use of complex filtering and highly accurate I/Q architecture, high sensitivity, and excellent linearity can be achieved.

DS14620 - Rev 2 page 6/52

AGC Timer and Power AGC control control RADIO\_TX\_SEQUENCE RF control RADIO\_RX\_SEQUENCE ADC◀ - Interrupt Wakeup ВP BLE modulator filter ADC◀ BLE RF1 4 controller BLE demodulator PLL See notes PA Adjust Adjust PA ramp generator HSE Trimmed SMPS LDO bias VDDSD VSSSD VLXSD VFBSD VDDRF

Figure 1. STM32WB05xN RF block diagram

Note: VFQFPN32: VSS through exposed pad, and VSSRF pins must be connected to the ground plane. WLCSP36: VSSRF pins must be connected to the ground plane.

## 3.2.2 IPDs for STM32WB05xN

Table 2 lists the available IPD variants for the STM32WB05xN device.

Table 2. IPDs for STM32WB05xN

| IPD           | MCU Package | STM32WB05xN part number |
|---------------|-------------|-------------------------|
| MLPF-NRG-01D3 | VFQFPN32    | STM32WB05KN             |
| WEFF-NKG-01D3 | WLCSP36     | STM32WB05TN             |

DS14620 - Rev 2 page 7/52



#### 3.3 Power supply management

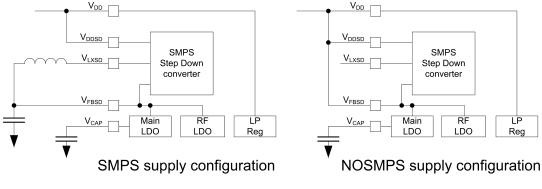
#### 3.3.1 SMPS step-down regulator

The device integrates a step-down converter to improve low power performance when the V<sub>DD</sub> voltage is high enough. The SMPS output voltage can be programmed from 1.2 V to 1.90 V. It is internally clocked at 4 MHz or 8 MHz.

The device can be operated without the SMPS by just wiring its output to VDD. This is the case for applications where the voltage is low, or where the power consumption is not critical.

Except for the configuration SMPS OFF, an L/C BOM must be present on the board and connected to the VFBSD

Figure 2. Power supply configuration



#### 3.3.2 **Power supply schemes**

The STM32WB05xN embeds three power domains:

- V<sub>DD33</sub> (V<sub>DDIO</sub> or V<sub>DD</sub>):
  - the voltage range is between 1.7 V and 3.6 V
  - it supplies a part of the I/O ring, the embedded regulators and the system analog IPs as power management block and embedded oscillators
- V<sub>DD120</sub>:
  - always-on digital power domain
  - this domain is generally supplied at 1.2 V during active phase of the device
  - this domain is supplied at 1.0 V during low power mode (Deepstop)
- V<sub>DD12i</sub>:
  - interruptible digital power domain
  - this domain is generally supplied at 1.2 V during active phase of the device
  - this domain is shut down during low power mode (Deepstop)

#### 3.3.3 Linear voltage regulators

The digital power supplies are provided by different regulators:

- The main LDO (MLDO):
  - it provides 1.2 V from a 1.4-3.3 V input voltage
  - it supplies both V<sub>DD12i</sub> and V<sub>DD12o</sub> when the device is active
  - it is disabled during the low power mode (Deepstop)

DS14620 - Rev 2 page 8/52

DT58134V



- Low power LDO (LPREG):
  - it stays enabled during both active and low power phases
  - it provides 1.0 V voltage
  - it is not connected to the digital domain when the device is active
  - it is connected to the V<sub>DD120</sub> domain during low power mode (Deepstop)
- A dedicated LDO (RFLDO) to provide a 1.2 V to the analog RF block

An embedded SMPS step-down converter is available (inserted between the external power and the LDOs).

#### 3.3.4 Power supply supervisor

The STM32WB05xN device embeds several power voltage monitoring:

- Power-on-reset (POR): during the power-on, the device remains in reset mode if V<sub>DDIO</sub> is below a V<sub>POR</sub> threshold (typically 1.65 V)
- Power-down-reset (PDR): during power-down, the PDR puts the device under reset when the supply voltage (V<sub>DD</sub>) drops below the V<sub>PDR</sub> threshold (around 20 mV below V<sub>POR</sub>). The PDR feature is always enabled
- Programmable voltage detector (PVD): can be used to monitor the V<sub>DDIO</sub> (against a programmed threshold) or an external analog input signal. When the feature is enabled and the PVD measures a voltage below the comparator, an interrupt is generated (if unmasked)

## 3.4 Reset management

The STM32WB05xN offers two different resets:

- The PORESETn: this reset is provided by the low power management unit (LPMU) analog block and
  corresponds to a POR or PDR root cause. It is linked to power voltage ramp-up or ramp-down. This reset
  impacts all resources of the . The exit from Shutdown mode is equivalent to a POR and thus generates a
  PORESETn. The PORESETn signal is active when the power supply of the device is below a threshold
  value or when the regulator does not provide the target voltage.
- The PADRESETn (system reset): this reset is built through several sources:
  - PORESETn
  - Reset due to the watchdog
    - The STM32WB05xN device embeds a watchdog timer, which may be used to recover from software crashes
  - Reset due to CPU Lockup
    - The Cortex-M0+ generates a lockup to indicate the core is in the lock-up state resulting from an unrecoverable exception. The lock-up reset is masked if a debugger is connected to the Cortex-M0+
  - Software system reset
    - The system reset request is generated by the debug circuitry of the Cortex-M0+. The debugger sets the SYSRESETREQ bit of the application interrupt and reset control register (AIRCR). This system reset request through the AIRCR can also be done by the embedded software (into the hardfault handler for instance)
  - Reset from the RSTN external pin
    - The RSTN pin toggles to inform that a reset has occurred

This PADRESETn resets all resources of the STM32WB05xN, except:

- Debug features
- Power controller unit

The pulse generator guarantees a minimum reset pulse duration of 20 µs for each internal reset source. In case of reset from the RSTN external pad, the reset pulse is generated when the pad is asserted low.

## 3.5 Operating modes

Several operating modes are defined for the STM32WB05xN:

- Run mode
- Deepstop mode
- Shutdown mode

DS14620 - Rev 2 page 9/52



| Table 3. Relat | tionship betweer | n the low power m | nodes and func | tional blocks |
|----------------|------------------|-------------------|----------------|---------------|
|                |                  |                   |                |               |

| Mode                          | Shutdown                    | Deepstop | IDLE               | Run                |
|-------------------------------|-----------------------------|----------|--------------------|--------------------|
| CPU                           | OFF                         | OFF      | OFF                | ON                 |
| Radio                         | OFF                         | OFF      | ON/OFF             | ON/OFF             |
| Supply system                 | OFF                         | OFF      | ON ( DC-DC ON/OFF) | ON ( DC-DC ON/OFF) |
| Register retention            | OFF                         | ON       | ON                 | ON                 |
| HS clock                      | OFF                         | OFF      | ON                 | ON                 |
| LS clock                      | OFF                         | ON/OFF   | ON                 | ON                 |
| Peripherals                   | OFF                         | OFF      | ON/OFF             | ON/OFF             |
| Wake on GPIOs                 | OFF                         | ON/OFF   | ON/OFF             | NA                 |
| Wake on reset pin             | ON                          | ON       | ON                 | NA                 |
| GPIOs configuration retention | PWRC pull-up/pull-down only | ON       | ON                 | ON                 |

#### 3.5.1 Run mode

In Run mode the STM32WB05xN is fully operational:

- All interfaces are active
- The internal power supplies are active
- The system clock and the bus clock are running
- The CPU core and the radio can be used

The power consumption may be reduced by gating the clock of the unused peripherals.

## 3.5.2 Deepstop mode

Deepstop is the only low-power mode of the STM32WB05xN allowing the restart from a saved context environment and the application at wake-up to go on running.

The conditions to enter Deepstop mode are:

- The radio is sleeping (no radio activity)
- The CPU is sleeping (WFI with SLEEPDEEP bit activated)
- No unmasked wake-up sources are active
- The low-power mode selection (LPMS) bit of the power controller unit is 0 (default)
- The GPIO Retention Mode Selection (GPIORET) bit of the Power Controller unit must be set

## In Deepstop mode:

- The system and the bus clocks are stopped
- Only the essential digital power domain is ON and supplied at 1.0 V
- The I/Os pull-up and pull-down can be controlled during Deepstop mode, depending on the software configuration
- The low speed clock can be running or stopped, depending on the software configuration:
  - ON or OFF
  - Sourced by LSE or by LSI
- The radio wake-up block, including its timer, stay active (if enabled and the low speed clock is ON)
- Up to 20 GPIOs retaining their configuration:
  - I/Os retain the Run mode configuration while in Deepstop mode
- Up to 20 I/Os are able to be in output driving:
  - A static low or high level
- Some I/Os are able to be in output driving:
  - The low speed clock (on PA10)

Possible wake-up sources are:

DS14620 - Rev 2 page 10/52



- The radio block is able to generate two events to wake up the system through its embedded wake-up timer running on low speed clock:
  - Radio wake-up time is reached
  - CPU host wake-up time is reached
- All GPIOs are able to wake up the system

At wake-up, all the hardware resources located in the digital power domain that are OFF during the Deepstop mode, are reset. The CPU reboots. The wake-up reason is visible in the register of the power controller.

#### 3.5.3 Shutdown mode

The Shutdown mode is the least power consuming mode.

The conditions to enter Shutdown mode are the same conditions needed to enter Deepstop mode except that the LPMS bit of the power controller unit is 1.

In Shutdown mode, the STM32WB05xN is in ultra-low-power consumption: all voltage regulators, clocks and the RF interface are not powered. The STM32WB05xN can enter shutdown mode by internal software sequence. The only way to exit shutdown mode is by asserting and deasserting the RSTN pin.

In Shutdown mode:

- The system is powered down as both the regulators are OFF
- The V<sub>DDIO</sub> power domain is ON
- All the clocks are OFF, LSI and LSE are OFF
- The I/Os pull-up and pull-down can be controlled during Shutdown mode, depending on the software configuration
- The only wake-up source is a low pulse on the RSTN pin

The exit from Shutdown is similar to a POR startup. The PDR feature can be enabled or disabled during Shutdown.

## 3.6 Clock management

Three different clock sources may be used to drive the system clock of the STM32WB05xN:

- HSI: high speed internal 64 MHz RC oscillator
- PLL64M: 64 MHz PLL clock
- HSE: high speed 32 MHz external crystal

The STM32WB05xN also has a low speed clock tree used by some timers in the radio.

Three different clock sources can be used for this low speed clock tree:

- Low speed internal (LSI): low speed and low drift internal RC with a fixed frequency between 24 kHz and 49 kHz depending on the sample
- Low speed external (LSE) from:
  - An external crystal 32.768 kHz
  - A single-ended 32.738 kHz input signal
- A 32 kHz clock derived from dividing HSI or HSE. In this case, the slow clock is not available in Deepstop low-power mode

By default, after a system reset, all low speed sources are OFF.

Both the activation and the selection of the slow clock are relevant during Deepstop mode and at wake-up as slow clock generates a clock for the timers involved in wake-up event generation.

The HSI and the PLL64M clocks are provided by the same analog block called RC64MPLL. The 64 MHz clock output by this block can be:

- A nonaccurate clock when no external XO provides an input clock to this block (HSI)
- An accurate clock when the external XO provides the 32 MHz and once its internal PLL is locked (PLL64M)

The following clocks are used:

- USART: it uses an always 16 MHz clock to have a fixed reference clock for baud rate management. The
  goal is to allow the CPU to boost or slow down the system clock (depending on on-going activities) without
  impacting a potential on-going serial interface transfer on external I/Os
- SPI: the baud rate is managed by the system clock. This implies its baud rate is impacted by dynamic system clock frequency changes.

DS14620 - Rev 2 page 11/52



Radio: it does not directly use the system clock for its APB/AHB interfaces, but the system clock with a
potential divider (1 or 2 or 4). In parallel, the radio uses an always 16 MHz and an always 32 MHz for
modulator, demodulator and to have a fixed reference clock to manage specific delays

## 3.7 General purpose inputs/outputs (GPIO)

Each of the GPIO pins can be configured by software as output (push-pull or open-drain), as input (with or without pull-up or pull-down) or as peripheral alternate function. Most of the GPIO pins are shared with digital or analog alternate functions. Fast I/O toggling can be achieved thanks to their mapping on the AHB0 bus.

The I/Os alternate function configuration can be locked if needed following a specific sequence in order to avoid spurious writing to the I/Os registers.

## 3.8 Direct memory access (DMA)

The DMA is used in order to provide high-speed data transfer between peripherals and memory as well as memory-to-memory. Data can be quickly moved by DMA without any CPU actions. In this manner, CPU resources are free for other operations.

The DMA controller has eight channels in total. Each has an arbiter to handle the priority among DMA requests. DMA main features are:

- Eight independently configurable channels (requests)
- Each of the eight channels is connected to dedicated hardware DMA requests, software trigger is also supported on each channel. This configuration is done by software
- Priorities among requests from channels of DMA are software programmable (four levels consisting of very high, high, medium, low) or hardware in case of equality (request 1 has priority over request 2, and so on)
- Independent source and destination transfer size (byte, half word, word), emulating packing and unpacking. Source/destination addresses must be aligned on the data size
- Support for circular buffer management
- Three event flags (DMA half transfer, DMA transfer complete and DMA transfer error) logically ORed together in a single interrupt request for each channel
- Memory-to-memory transfer (RAM only)
- · Peripheral-to-memory and memory-to-peripheral, and peripheral-to-peripheral transfers
- Access to SRAMs, APB0 and APB1 peripherals as source and destination
- Programmable number of data to be transferred: up to 65536

## 3.9 Nested vectored interrupt controller (NVIC)

The interrupts are handled by the Cortex-M0+ nested vector interrupt controller (NVIC). NVIC controls specific Cortex-M0+ interrupts as well as the STM32WB05xN peripheral interrupts.

The NVIC benefits are the following:

- Nested vectored interrupt controller that is an integral part of the ARM Cortex-M0+
- Tightly coupled interrupt controller provides low interrupt latency
- Control system exceptions and peripheral interrupts
- NVIC supports 32 vectored interrupts
- Four programmable interrupt priority levels with hardware priority level masking
- Software interrupt generation using the ARM exceptions SVCall and PendSV
- Support for NMI
- ARM Cortex M0+ vector table offset register VTOR implemented

NVIC hardware block provides flexible interrupt management features with minimal interrupt latency.

## 3.10 Universal synchronous/asynchronous receiver transmitter (USART)

USART offers flexible full-duplex data exchange with external equipment requiring an industry standard NRZ asynchronous serial data format. USART is able to communicate with a speed up to 2 Mbit/s. Furthermore, USART is able to detect and automatically set its own baud rate, based on the reception of a single character. High speed data communication is possible by using DMA (direct memory access) for multibuffer configuration.

DS14620 - Rev 2 page 12/52



## 3.11 Serial peripheral interface (SPI)

The STM32WB05xN has one SPI interface (SPI3) allowing communication up to 32 Mbit/s in both master and slave modes. The SPI peripheral supports:

- Master or slave operation
- Multimaster support
- Full-duplex synchronous transfers on three lines
- Half-duplex synchronous transfer on two lines (with bidirectional data line)
- Simplex synchronous transfers on two lines (with unidirectional data line)
- Serial communication with external devices
- NSS management by hardware or software for both master and slave: dynamic change of master/slave operations
- SPI Motorola support
- SPI TI mode support
- Hardware CRC feature for reliable communication

All SPI interfaces can be served by the DMA controller.

## 3.12 Serial wire debug port

The STM32WB05xN embeds an ARM SWD interface that allows interactive debugging and programming of the device. The interface is composed of only two pins: DEBUG\_SWDIO and DEBUG\_SWCLK. The enhanced debugging features for developers allow up to 4 breakpoints and up to 2 watchpoints.

### 3.13 TX and RX event alert

The STM32WB05xN is provided with the RADIO\_TX\_SEQUENCE and RADIO\_RX\_SEQUENCE signals which alert, respectively, transmission and reception activities.

A signal can be enabled for TX and RX on two pins, through alternate functions:

- RADIO\_TX\_SEQUENCE is available on PA10 (AF2) or PB14 (AF1).
- RADIO\_RX\_SEQUENCE is available on PA8 (AF2) or PA11 (AF2).

The signal is high when radio is in TX (or RX), low otherwise.

The signals can be used to control external antenna switching and support coexistence with other wireless technologies.

Note:

The RADIO\_RF\_ACTIVITY signal is used to notify if there is an ongoing RF operation (either TX or RX). It is a logical OR between the RADIO\_RX\_SEQUENCE and RADIO\_TX\_SEQUENCE. This signal can be used to enable an antenna switch component when achieving antenna switching during AoA or AoD operation.

## 3.14 Direction finding

The STM32WB05xN Bluetooth® radio controller supports the angle of arrival (AoA) and angle of departure (AoD) features by managing:

- the constant tone extension (CTE) inside a packet
- the antenna switching mechanism for both AoA and AoD.

The antenna switching mechanism provides a 7-bit antenna identifier RADIO\_ANTENNA\_ID[6:0] indicating the antenna number to be used.

In a AoD transmitter or in a AoA receiver, the radio needs to switch antenna during the CTE field of the packet. For this purpose, the RADIO\_ANTENNA\_ID signal can be enabled on some I/Os, by programming them in the associated alternate function. This signal needs to be provided to an external antenna switching circuit, since RADIO\_ANTENNA\_ID[0] is the least significant bit and ANTENNA\_ID[6] the most significant bit of the antenna identifier to be used.

DS14620 - Rev 2 page 13/52



# 4 Pinouts and pin description

The STM32WB05xN comes in two package versions: WLCSP36 offering 20 GPIOs and VFQFPN32 offering 20 GPIOs.

VDD1 PB4 PB5 RSTN VCAP VFBSD VSS VLXSD 32 31 30 29 28 27 26 25 PB3 **VDDSD** 1 24 PB2 PB6 2 23 PB1 PB7 3 22 PB0 PB12 4 21 GND PAD PB13 PA3 5 20 PA2 6 PB14 PA1 7 PB15 18 PA0 OSCIN 8 17 9 10 11 12 13 14 15 16 PA8 PA9 PA10 PA11 VDD2 RF1 VDDRF OSCOUT

Figure 3. Pinout top view (VFQFPN32 package)

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page 14/52

DS14620 - Rev 2

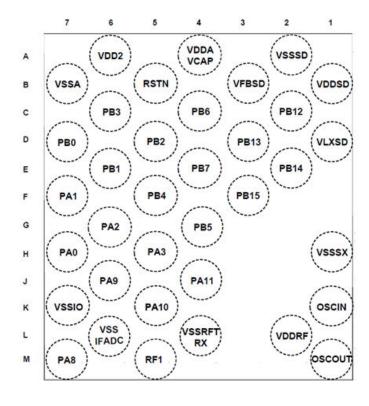


Figure 4. Pinout bump side view (WLCSP36 package)

DT58139V1



**Table 4. Pin descriptions** 

| Pin nı   | umber   | Pin name               |          | I/O       |   |                                    |
|----------|---------|------------------------|----------|-----------|---|------------------------------------|
| VFQFPN32 | WLCSP36 | (function after reset) | Pin type | structure | Alternate functions                         | Additional functions               |
| 1        | C6      | PB3                    | I/O      | FT_a      | USART_CTS, SPI3_SCK,<br>RADIO_ANTENNA_ID[3] | PWR_WKUP3                          |
| 2        | D5      | PB2                    | I/O      | FT_a      | USART_RTS_DE,<br>RADIO_ANTENNA_ID[2]        | PWR_WKUP2                          |
| 3        | E6      | PB1                    | I/O      | FT_a      | USART_CK, RADIO_ANTENNA_ID[1]               | PWR_WKUP1                          |
| 4        | D7      | PB0                    | I/O      | FT_a      | USART_RX, RADIO_ANTENNA_ID[0]               | PWR_WKUP0                          |
| 5        | H5      | PA3                    | I/O      | FT_a      | DEBUG_SWCLK, USART_RTS_DE,<br>SPI3_SCK      | PWR_WKUP15                         |
| 6        | G6      | PA2                    | I/O      | FT_a      | DEBUG_SWDIO, USART_CK                       | PWR_WKUP14                         |
| 7        | F7      | PA1                    | I/O      | FT_f      | USART_TX                                    | PWR_WKUP13                         |
| 8        | H7      | PA0                    | I/O      | FT_f      | USART_CTS                                   | PWR_WKUP12                         |
| 9        | M7      | PA8                    | I/O      | FT        | USART_RX, RADIO_RX_SEQUENCE,<br>SPI3_MISO   | PWR_WKUP8, RTC_OUT                 |
| 10       | J6      | PA9                    | I/O      | FT        | USART_TX, RTC_OUT, SPI3_NSS                 | PWR_WKUP9                          |
| 11       | K5      | PA10                   | I/O      | FT        | RADIO_TX_SEQUENCE, I2S3_MCK                 | PWR_WKUP10                         |
| 12       | J4      | PA11                   | I/O      | FT        | RADIO_RX_SEQUENCE, SPI3_MOSI                | PWR_WKUP11                         |
| 13       | A6      | VDD2                   | S        | -         | -   | 1.7-3.6 battery voltage input      |
| 14       | M5      | RF1                    | I/O      | RF        | -   | RF input/output.<br>Impedance 50 Ω |
| 15       | L2      | VDDRF                  | S        | -         | -   | 1.7-3.6 battery voltage input      |
| 16       | M1      | OSCOUT                 | I/O      | FT_a      | -   | 32 MHz crystal                     |
| 17       | K1      | OSCIN                  | I/O      | FT_a      | -   | 32 MHz crystal                     |
| 18       | F3      | PB15                   | I/O      | FT_a      | USART_TX                                    | PWR_WKUP19                         |
| 19       | E2      | PB14                   | I/O      | FT_a      | RADIO_TX_SEQUENCE, USART_RX                 | PWR_PVD_IN,<br>PWR_WKUP18          |
| 20       | D3      | PB13                   | I/O      | FT_a      | -   | PWR_WKUP17                         |
| 21       | C2      | PB12                   | I/O      | FT_a      | -   | PWR_WKUP16                         |
| 22       | E4      | PB7                    | I/O      | FT_f      | USART_CTS, RADIO_RF_ACTIVITY                | PWR_WKUP7                          |
| 23       | C4      | PB6                    | I/O      | FT_f      | RADIO_ANTENNA_ID[6]                         | PWR_WKUP6                          |
| 24       | B1      | VDDSD                  | S        | -         | -   | 1.7-3.6 battery voltage input      |
| 25       | D1      | VLXSD                  | S        | -         | -   | SMPS input/output                  |
| 26       | A2      | VSSSD                  | S        | -         | -   | SMPS Ground                        |
| 27       | В3      | VFBSD                  | S        | -         | -   | SMPS output                        |
| 28       | A4      | VDDA_<br>VCAP          | S        | -         | -   | 1.2 V digital core                 |
| 29       | B5      | RSTN                   | I/O      | RST       | -   | Reset pin                          |
| 30       | G4      | PB5                    | I/O      | FT_a      | RADIO_ANTENNA_ID[5]                         | PWR_WKUP5                          |
| 31       | F5      | PB4                    | I/O      | FT_a      | RADIO_ANTENNA_ID[4]                         | PWR_WKUP4                          |
| 32       | -       | VDD1                   | S        | -         | -   | 1.7-3.6 battery voltage input      |

DS14620 - Rev 2 page 16/52



| Pin nu      | Pin number |                        | Dia taura | I/O       | Albania da Gara di ana | Additional formations |
|-------------|------------|------------------------|-----------|-----------|------------------------|-----------------------|
| VFQFPN32    | WLCSP36    | (function after reset) | Pin type  | structure | Alternate functions    | Additional functions  |
| -           | В7         | VSSA                   | S         | -         | -                      | -                     |
| -           | k7         | VSSIO                  | S         | -         | -                      | Ground I/O            |
| -           | L6         | VSSIFADC               | S         | -         | -                      | Ground analog RF      |
| -           | H1         | VSSSX                  | S         | -         | -                      | Ground analog RF      |
| -           | L4         | VSSRFTRX               | S         | -         | -                      | Ground analog RF      |
| Exposed pad | -          | GND                    | S         | -         | -                      | Ground                |

Table 5. Legend/abbreviations used in the pinout table

|               | Name                 | Abbreviation   | Definition   |  |  |  |
|---------------|----------------------|--|--|--|--|--|
| Р             | in name              | Unless otherwise specified in brackets below, the pin name and the pin function during and after reset are the same as the actual pin name |  |  |  |  |
|               |                      | S  | Supply pin   |  |  |  |
| F             | Pin type             | I  | Input only pin   |  |  |  |
|               |                      | I/O  | Input / output pin   |  |  |  |
|               |                      | FT   | 5 V tolerant I/O   |  |  |  |
|               |                      | TT   | 3.6 V tolerant I/O   |  |  |  |
|               |                      | RF   | RF I/O   |  |  |  |
| I/O           | structure            | RST Bidirectional reset pin with weak pull-up re-  |  |  |  |  |
| ., 0          | on dotaro            | Options for TT or FT I/Os  |  |  |  |  |
|               |                      | _f <sup>(1)</sup> .  | I/O, Fm+ capable   |  |  |  |
|               |                      | _a <sup>(2)</sup> .  | I/O, with analog switch function supplied by IO BOOSTER <sup>(3)</sup> |  |  |  |
| Notes         |                      | Unless otherwise specified by a note, all I/Os are set as analog inputs during and after reset   |  |  |  |  |
| Din functions | Alternate functions  | Functions selected through GPIOx_AFF   | R registers  |  |  |  |
| Pin functions | Additional functions | Functions directly selected/enabled thro   | ough peripheral registers  |  |  |  |

- 1. The related I/O structures in Section 4: Pinouts and pin description are: FT\_f
- 2. The related I/O structures in Section 4: Pinouts and pin description are: FT\_a
- 3. IO BOOSTER block allows the good behavior of those switches to be guaranteed when the VBAT goes below 2.7 V.

DS14620 - Rev 2 page 17/52



Table 6. Alternate function port A

| В      | ort  | AF0          | AF1          | AF2                   | AF3       | AF5         | AF7         |
|--------|------|--------------|--------------|-----------------------|-----------|-------------|-------------|
|        | ort  | SYS_AF/USART | USART        | RTC USART/RF          | SPI3      | SYS_AF      | SYS_AF      |
|        | PA0  | -            | USART_CTS    | -                     | -         | -           | -           |
|        | PA1  | -            | -            | USART_TX              | -         | -           | -           |
|        | PA2  | DEBUG_SWDIO  | USART_CK     | -                     | -         | DEBUG_SWDIO | DEBUG_SWDIO |
|        | PA3  | DEBUG_SWCLK  | USART_RTS_DE | -                     | SPI3_SCK  | DEBUG_SWCLK | DEBUG_SWCLK |
| Port A | PA8  | USART_RX     | -            | RADIO_RX_<br>SEQUENCE | SPI3_MISO | -           | -           |
|        | PA9  | USART_TX     | -            | RTC_OUT               | SPI3_NSS  | -           | -           |
|        | PA10 | -            | -            | RADIO_TX_<br>SEQUENCE | -         | -           | -           |
|        | PA11 | -            | -            | RADIO_RX_<br>SEQUENCE | SPI3_MOSI | -           | -           |

Table 7. Alternate function port B

| Po     | . urk | AF0          | AF1               | AF2       | AF3         | AF4      | AF6                 | AF7 |
|--------|-------|--------------|-------------------|-----------|-------------|----------|---------------------|-----|
| PC     | ort   | USART        | SYS_AF            | -         | TIM2/SYS_AF | SPI3     | RF/USART            | -   |
|        | PB0   | USART_RX     | -                 | -         | -           | -        | RADIO_ANTENNA_ID[0] | -   |
|        | PB1   | USART_CK     | -                 | -         | -           | -        | RADIO_ANTENNA_ID[1] | -   |
|        | PB2   | USART_RTS_DE | -                 | -         | -           | -        | RADIO_ANTENNA_ID[2] | -   |
|        | PB3   | USART_CTS    | -                 | -         | -           | SPI3_SCK | RADIO_ANTENNA_ID[3] | -   |
|        | PB4   | -            | -                 | -         | -           | -        | RADIO_ANTENNA_ID[4] | -   |
| Port B | PB5   | -            | -                 | -         | -           | -        | RADIO_ANTENNA_ID[5] | -   |
| POILB  | PB6   | -            | -                 | -         | -           | -        | RADIO_ANTENNA_ID[6] | -   |
|        | PB7   | -            | -                 | USART_CTS | -           | -        | RADIO_RF_ACTIVITY   | -   |
|        | PB12  | -            | -                 | -         | -           | -        | -                   | -   |
|        | PB13  | -            | -                 | -         | -           | -        | -                   | -   |
|        | PB14  | -            | RADIO_TX_SEQUENCE | -         | -           | -        | USART_RX            | -   |
|        | PB15  | -            | -                 | -         | -           | -        | USART_TX            | -   |

DS14620 - Rev 2 page 18/52



# **Application circuits**

The schematics below are purely indicative.

Figure 5. Application circuit: DC-DC converter, WLCSP36 package

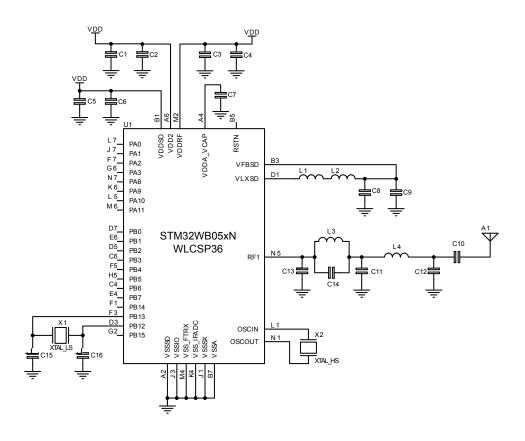
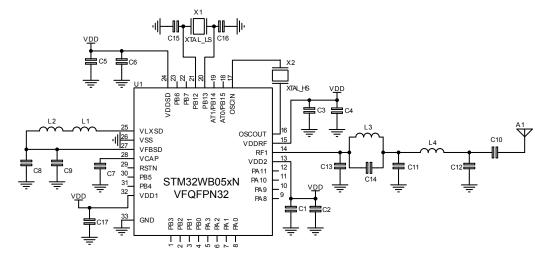


Figure 6. Application circuit: DC-DC converter, VFQFPN32 package



DS14620 - Rev 2





Table 8. Application circuit external components

| Component | Description                      |
|-----------|----------------------------------|
| C1        | Decoupling capacitor             |
| C2        | Decoupling capacitor             |
| C3        | Decoupling capacitor             |
| C4        | Decoupling capacitor             |
| C5        | Decoupling capacitor             |
| C6        | Decoupling capacitor             |
| C7        | Main LDO capacitor               |
| C8        | DC-DC converter output capacitor |
| C9        | DC–DC converter output capacitor |
| C10       | DC block capacitor               |
| C11       | RF matching capacitor            |
| C12       | RF Matching capacitor            |
| C13       | RF Matching capacitor            |
| C14       | RF Matching capacitor            |
| C15       | 32 kHz crystal loading capacitor |
| C16       | 32 kHz crystal loading capacitor |
| C17       | Decoupling capacitor             |
| L1        | DC-DC converter output inductor  |
| L2        | DC-DC converter noise filter     |
| L3        | RF matching inductor             |
| L4        | RF matching inductor             |
| X1        | Low speed crystal                |
| X2        | High speed crystal               |
| U1        | STM32WB05xN                      |

Note:

In order to make the board DC–DC OFF, the inductance L1 must be removed and the supply voltage must be applied to the VFBSD pin.

page 20/52

## Electrical characteristics

## 6.1 Parameter conditions

Unless otherwise specified, all voltages are referenced to ground (GND).

#### 6.1.1 Minimum and maximum values

Unless otherwise specified, the minimum and maximum values are guaranteed in the following standard conditions:

- Ambient temperature is T<sub>A</sub> = 25 °C
- Supply voltage is V<sub>DD</sub>: 3.3 V
- System clock frequency is 32 MHz (clock source HSI)
- SMPS clock frequency is 4 MHz

Data based on characterization results, design simulation and/or technology characteristics are indicated in the table footnotes and are not tested in production. Based on characterization, the minimum and maximum values refer to sample tests and represent the mean value plus or minus three times the standard deviation (mean  $\pm 3\sigma$ ).

## 6.1.2 Typical values

Unless otherwise specified, typical data are based on  $T_A$  = 25 °C,  $V_{DD}$  = 3.3 V. They are given only as design guidelines and are not tested.

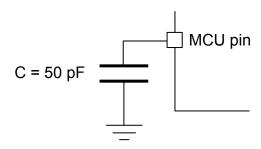
## 6.1.3 Typical curves

Unless otherwise specified, all typical curves are only given as design guidelines and are not tested.

## 6.1.4 Loading capacitor

The loading conditions used for pin parameter measurement are shown in the figure below.

Figure 7. Pin loading conditions



57473V1

page 21/52

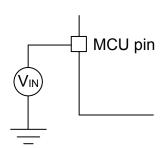
DS14620 - Rev 2



## 6.1.5 Pin input voltage

The input voltage measurement on a pin of the device is described in the figure below.

Figure 8. Pin input voltage



T57474V

## 6.2 Absolute maximum ratings

Stresses above the absolute maximum ratings listed in the tables below, may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these conditions is not implied. Exposure to maximum rating conditions for extended periods may affect device reliability.

**Table 9. Voltage characteristics** 

| Symbol   | Ratings   | Min. | Max.  | Unit |
|--|---|------|-------|------|
| $V_{DD1}, V_{DD2}, V_{DD3}, V_{DD4}, V_{DDRF}, V_{DDSD}$ | DC-DC converter supply voltage input and output                             | -0.3 | +3.9  |      |
| V <sub>DDA_VCAP</sub>                                    | DC voltage on linear voltage regulator                                      | -0.3 | +1.32 |      |
| FXTALOUT, FXTALIN  | DC Voltage on HSE   | -0.3 | 1.32  | V    |
| PA0 to PA15, PB0 to PB15                                 | DC voltage on digital input/output pins                                     | -0.3 | +3.9  | V    |
| $V_{LXSD}, V_{FBSD}$                                     | DC voltage on analog pins   | -0.3 |       |      |
| PB12, PB13   | DC voltage on crystal pins  | -0.3 | +3.6  |      |
| RF1  | DC voltage on RF pin  | -0.5 | +1.4  | -    |
| $ \Delta V_{DD} $  | Variations between different $V_{\text{DDX}}$ power pins of the same domain | -    | 50    | mV   |

Note:

All the main power and ground pins must always be connected to the external power supply, in the permitted range.

Table 10. Current characteristics

| Symbol                 | Ratings  | Max. | Unit |
|------------------------|--|------|------|
| $\Sigma IV_{DD}$       | Total current into sum of all VDD power lines (source)           | 130  |      |
| $\Sigma IV_{GND}$      | Total current out of sum of all ground lines (sink)              | 130  |      |
| IV <sub>DD(PIN)</sub>  | Maximum current into each VDD power pin (source)                 | 100  |      |
| IV <sub>GND(PIN)</sub> | Maximum current out of each ground pin (sink)                    | 100  |      |
| lio (DIN)              | Output current sunk by any I/O and control pin                   | 20   | mA   |
| I <sub>IO(PIN)</sub>   | Output current sourced by any I/O and control pin                | 20   |      |
| ΣΙωσιν                 | Total output current sunk by sum of all I/Os and control pins    | 100  |      |
| ΣI <sub>IO(PIN)</sub>  | Total output current sourced by sum of all I/Os and control pins | 100  |      |
| $\Sigma I_{INJ(PIN)} $ | Total injected current (sum of all I/Os and control pins)        | -5/0 |      |

DS14620 - Rev 2 page 22/52



**Table 11. Thermal characteristics** 

| Symbol           | Ratings                      | Value       | Unit |
|------------------|------------------------------|-------------|------|
| T <sub>STG</sub> | Storage temperature range    | -40 to -125 | °C   |
| T <sub>J</sub>   | Maximum junction temperature | 125         | C    |

# 6.3 Operating conditions

## 6.3.1 Summary of main performance

Table 12. Main performance SMPS ON

| Symbol               | Parameter                | Test conditions   | Typ.<br>V <sub>DD</sub> = 1.8 V | Typ.<br>V <sub>DD</sub> = 3.3 V | Unit   |
|----------------------|--------------------------|---|---------------------------------|---------------------------------|--------|
|                      |                          | Shutdown  | 8                               | 19                              | nA     |
|                      |                          | Deepstop, no timer, wake-up<br>GPIO, all RAM retained                                 | 0.63                            | 0.64                            |        |
|                      |                          | Deepstop (32 kHz LSI), all RAMs retained  | 1.09                            | 1.15                            | μΑ     |
|                      |                          | Deepstop (32 kHz LSE), all RAM retained   | 0.88                            | 0.99                            |        |
|                      |                          | CPU in Run (64 MHz).<br>Dhrystone, clock source PLL64                                 | -                               | 2638                            |        |
|                      | Core current consumption | CPU in Run (32 MHz).<br>Dhrystone, clock source PLL64                                 | -                               | 2186                            |        |
| I <sub>CORE</sub>    |                          | CPU in WFI (64 MHz), all<br>peripherals off, clock source<br>PLL64                    | -                               | 1688                            |        |
|                      |                          | CPU in WFI (16 MHz), all<br>peripherals off, clock source<br>Direct HSE               | -                               | 1000                            | μΑ     |
|                      |                          | Radio RX at sensitivity level   | -                               | 3350                            |        |
|                      |                          | Radio TX 0 dBm output power   | -                               | 4300                            |        |
|                      |                          | Radio RX at sensitivity level with<br>CPU in WFI (32 MHz), clock<br>source Direct HSE | -                               | 4950                            |        |
|                      |                          | Radio TX 0 dBm output power<br>with CPU in WFI (32 MHz), clock<br>source Direct HSE   | -                               | 5600                            |        |
| I <sub>DYNAMIC</sub> | Dynamic current          | Computed value: (CPU 64 MHz<br>Dhrystone - CPU 32 MHz<br>Dhrystone) / 32              | -                               | 14                              | μΑ/MHz |

DS14620 - Rev 2 page 23/52



Table 13. Main performance SMPS bypassed

| Symbol            | Parameter                | Test conditions  | Typ.<br>V <sub>DD</sub> = 1.8 V | Typ.<br>V <sub>DD</sub> = 3.3 V | Unit |
|-------------------|--------------------------|--|---------------------------------|---------------------------------|------|
|                   |                          | Shutdown   | 8                               | 19                              | nA   |
|                   |                          | Deepstop, no timer,<br>wake-up GPIO, all<br>RAM retained                                 | 0.63                            | 0.64                            |      |
|                   |                          | Deepstop (32 kHz<br>LSI), all RAMs<br>retained   | 1.09                            | 1.15                            |      |
|                   |                          | Deepstop (32 kHz<br>LSE), all RAM retained   | 0.88                            | 0.99                            |      |
|                   |                          | CPU in Run (64 MHz).<br>Dhrystone, clock<br>source PLL64                                 | -                               | 4450                            |      |
|                   |                          | CPU in WFI (64 MHz),<br>all peripherals off,<br>clock source PLL64                       | -                               | 2313                            |      |
| I <sub>CORE</sub> | Core current consumption | CPU in WFI (16 MHz),<br>all peripherals off,<br>clock source Direct<br>HSE               | -                               | 700                             | μΑ   |
|                   |                          | Radio RX at sensitivity level  | -                               | 6700                            |      |
|                   |                          | Radio TX 0 dBm output power  | -                               | 8900                            |      |
|                   |                          | Radio RX at sensitivity<br>level with CPU in WFI<br>(32MHz), clock source<br>Direct HSE  | -                               | 9200                            |      |
|                   |                          | Radio TX 0 dBm<br>output power with<br>CPU in WFI (32MHz),<br>clock source Direct<br>HSE | -                               | 11000                           |      |

Table 14. Peripheral current consumption at  $V_{DD}$  = 3.3 V, system clock (CLK\_SYS), SMPS on

| Parameter | Test conditions | Тур. | Unit |
|-----------|-----------------|------|------|
| DMA       | -               | 37   |      |
| GPIOA     | -               | 2    |      |
| GPIOB     | -               | 2    |      |
| SPI3      | -               | 46   | μΑ   |
| USART     | -               | 79   |      |
| SYSCFG    | -               | 22   |      |

DS14620 - Rev 2 page 24/52



## 6.3.2 General operating conditions

Table 15. General operating conditions

| Symbol              | Parameter  | Conditions                | Min.                    | Max.                 | Unit  |
|---------------------|--|---------------------------|-------------------------|----------------------|-------|
| f <sub>HCLK</sub>   | Internal AHB clock frequency                               | -                         | 1                       | 64                   |       |
| f <sub>PCLK0</sub>  | Internal APB0 clock  | -                         | 1                       | 64                   | MHz   |
| f <sub>PCLK1</sub>  | Internal APB1 clock frequency                              | -                         | <b>1</b> <sup>(1)</sup> | 64                   | IVITZ |
| f <sub>PCLK2</sub>  | Internal APB2 clock frequency                              | -                         | 16                      | 32                   |       |
| $V_{DD}$            | Standard operating voltage                                 | -                         | 1.7                     | 3.6                  |       |
| V <sub>FBSMPS</sub> | SMPS feedback voltage                                      | -                         | 1.4                     | 3.6                  | V     |
| $V_{DDRF}$          | Minimum RF voltage   | -                         | 1.7                     | 3.6                  | V     |
| V <sub>IN</sub>     | I/O input voltage  | -                         | -0.3                    | V <sub>DD</sub> +0.3 |       |
| P <sub>D</sub>      | Power dissipation at T <sub>A</sub> =105 °C <sup>(2)</sup> | VFQFPN32 package          | -                       | 30                   | mW    |
| T <sub>A</sub>      | Ambient temperature  | Maximum power dissipation | -40                     | 105                  | °C    |
| TJ                  | Junction temperature range                                 | -                         | -40                     | 105                  |       |

<sup>1.</sup> It could be 0 if all the peripherals are disabled.

DS14620 - Rev 2 page 25/52

<sup>2.</sup>  $T_A$  cannot exceed  $T_J$  max.



## 6.3.3 RF general characteristics

All performance data are referred to a 50  $\Omega$  antenna connector, via reference design.

Table 16. Bluetooth Low Energy RF general characteristics

| Symbol             | Parameter  | Test conditions   | Min. | Тур. | Max.   | Unit  |
|--------------------|--|---|------|------|--------|-------|
| F <sub>RANGE</sub> | Frequency range <sup>(1)</sup>   | -   | 2400 | -    | 2483.5 | MHz   |
| RF <sub>CH</sub>   | RF channel center frequency <sup>(1)</sup>                                       | -   | 2402 | -    | 2480   | IVIHZ |
| PLL <sub>RES</sub> | RF channel spacing <sup>(1)</sup>  | -   | -    | 2    | -      | MHz   |
| ΔF                 | Frequency deviation <sup>(1)</sup>   | -   | -    | 250  | -      | kHz   |
| Δf1                | Frequency deviation average <sup>(1)</sup>                                       | -   | 450  | -    | 550    | kHz   |
| C <sub>Fdev</sub>  | Center frequency deviation <sup>(1)</sup>  | During the packet and including both initial frequency offset and drift | -    | -    | ±150   | kHz   |
| Δfa                | Frequency deviation $\Delta f2$ (average) / $\Delta f1$ (average) <sup>(1)</sup> | -   | 0.80 | -    | -      | -     |
| R <sub>gfsk</sub>  | On-air data rate <sup>(1)</sup>  | -   | 1    | -    | 2      | Mbps  |
| STacc              | Symbol time accuracy <sup>(1)</sup>  | -   | -    | -    | ±50    | ppm   |
| MOD                | Modulation scheme  | -   |      | GFSI | <      | -     |
| ВТ                 | Bandwidth-bit period product   | -   | -    | 0.5  | -      | -     |
| Mindex             | Modulation index <sup>(1)</sup>  | -   | 0.45 | 0.5  | 0.55   | -     |
| PMAX               | Maximum output   | At antenna connector, VSMPS = 1.9 V,<br>LDO code                        | -    | +8   | -      | dBm   |
| PMIN               | Minimum output   | At antenna connector  | -    | -20  | -      | dBm   |
| PRFC               | RF power accuracy  | @ 27 °C   | -    | ±1.5 | -      | dB    |
| TICLE              | ixi power accuracy   | All temperatures  | -    | ±2.5 | -      | ub    |

<sup>1.</sup> Tested according to Bluetooth SIG radio frequency physical layer (RF PHY) test suite (not tested in production).

## **6.3.4** RF transmitter characteristics

All performance data are referred to a 50  $\boldsymbol{\Omega}$  antenna connector, via reference design.

Table 17. Bluetooth Low Energy RF transmitter characteristics at 1 Mbps not coded

| Symbol                    | Parameter   | Test conditions  | Min. | Тур. | Max. | Unit         |
|---------------------------|---|--|------|------|------|--------------|
| P <sub>BW1M</sub>         | 6 dB bandwidth for modulated carrier                        | Using resolution bandwidth of 100 kHz  | 500  | -    | -    | kHz          |
| P <sub>RF1</sub> , 1 Ms/s | In-band emission at ±2 MHz <sup>(1)</sup>                   | Using resolution bandwidth of 100 kHz and average detector                   | -    | -46  | -    | dBm          |
| P <sub>RF2</sub> , 1 Ms/s | In-band emission at ±[3+n]MHz, where n=0,1,2 <sup>(1)</sup> | Using resolution bandwidth of 100 kHz and average detector                   | -    | -46  | -    | dBm          |
| PS <sub>PUR</sub>         | Spurious emission   | Harmonics included. Using resolution bandwidth of 1 MHz and average detector | -    | -    | -41  | dBm          |
| Freq <sub>drift</sub>     | Frequency drift <sup>(1)</sup>                              | Integration interval #n – integration interval #0, where n=2,3,4k            | -50  | -    | +50  | kHz          |
| IFreq <sub>drift</sub>    | Initial carrier frequency drift <sup>(1)</sup>              | Integration interval #1 – integration interval #0                            | -23  | -    | +23  | kHz          |
| Int <sub>Freqdrift</sub>  | Intermediate carrier frequency drift <sup>(1)</sup>         | Integration interval #n – integration interval #(n-5), where n=6,7,8k        | -20  | -    | +20  | kHz          |
| Drift Rate max            | Maximum drift rate <sup>(1)</sup>                           | Between any two 10-bit groups separated by 50 µs                             | -20  | -    | +20  | kHz/50<br>µs |

DS14620 - Rev 2 page 26/52



| Symbol | Parameter              | Test conditions | Min. | Тур. | Max. | Unit |   |
|--------|------------------------|-----------------|------|------|------|------|---|
| 7      | Optimum RF load        | @ 2440 MHz      |      | 40   | 40   |      | 0 |
| ∠RF1   | (impedance at RF1 pin) | @ 2440 MHz      | -    | 40   | -    | 22   |   |

<sup>1.</sup> Tested according to Bluetooth SIG radio frequency physical layer (RF PHY) test suite (not tested in production).

Table 18. Bluetooth Low Energy RF transmitter characteristics at 2 Mbps not coded

| Symbol                    | Parameter   | Test conditions  | Min. | Тур. | Max. | Unit     |
|---------------------------|---|--|------|------|------|----------|
| P <sub>BW1M</sub>         | 6 dB bandwidth for modulated carrier                        | Using resolution bandwidth of 100 kHz  | 670  | -    | -    | kHz      |
| P <sub>RF1</sub> , 2 Ms/s | In-band emission at ±4 MHz <sup>(1)</sup>                   | Using resolution bandwidth of 100 kHz and average detector                   | -    | -47  | -    | dBm      |
| P <sub>RF2</sub> , 2 Ms/s | In-band emission at±5 MHz <sup>(1)</sup>                    | Using resolution bandwidth of 100 kHz and average detector                   | -    | -47  | -    | dBm      |
| P <sub>RF3</sub> , 2 Ms/s | In-band emission at ±[6+n]MHz, where n=0,1,2 <sup>(1)</sup> | Using resolution bandwidth of 100 kHz and average detector                   | -    | -51  | -    | dBm      |
| P <sub>SPUR</sub>         | Spurious emission   | Harmonics included. Using resolution bandwidth of 1 MHz and average detector | -    | -    | -41  | dBm      |
| Freq <sub>drift</sub>     | Frequency drift <sup>(1)</sup>                              | Integration interval #n – integration interval #0, where n=2,3,4k            | -50  | -    | +50  | kHz      |
| IFreq <sub>drift</sub>    | Initial carrier frequency drift <sup>(1)</sup>              | Integration interval #1 – integration interval #0                            | -23  | -    | +23  | kHz      |
| IntFreq <sub>drift</sub>  | Intermediate carrier frequency drift <sup>(1)</sup>         | Integration interval #n – integration interval #(n-5), where n=6,7,8k        | -20  | -    | +20  | kHz      |
| DriftRate <sub>max</sub>  | Maximum drift rate <sup>(1)</sup>                           | Between any two 20-bit groups separated by 50 µs                             | -20  | -    | +20  | kHz/50µs |
| Z <sub>RF1</sub>          | Optimum RF load<br>(impedance at RF1 pin)                   | @ 2440 MHz   | -    | 40   | -    | Ω        |

<sup>1.</sup> Tested according to Bluetooth SIG radio frequency physical layer (RF PHY) test suite (not tested in production).

Table 19. Bluetooth Low Energy RF transmitter characteristics at 1 Mbps LE coded (S=8)

| Symbol                     | Parameter  | Test conditions  | Min.  | Тур. | Max.  | Unit         |
|----------------------------|--|--|-------|------|-------|--------------|
| P <sub>BW</sub>            | 6 dB bandwidth for modulated carrier                         | Using resolution bandwidth of 100 kHz  | 500   | -    | -     | kHz          |
| P <sub>RF1, LE</sub> coded | In-band emission at ±2 MHz <sup>(1)</sup>                    | Using resolution bandwidth of 100 kHz and average detector                   | -     | -46  | -     | dBm          |
| P <sub>RF2, LE</sub> coded | In-band emission at ±[3+n] MHz, where n=0,1,2 <sup>(1)</sup> | Using resolution bandwidth of 100 kHz and average detector                   | -     | -46  | -     | dBm          |
| PS <sub>PUR</sub>          | Spurious emission  | Harmonics included. Using resolution bandwidth of 1 MHz and average detector | -     | -    | -41   | dBm          |
| Freq <sub>drift</sub>      | Frequency drift <sup>(1)</sup>                               | Integration interval #n – integration interval #0, where n=1,2,3k            | -50   | -    | +50   | kHz          |
| IFreq <sub>drift</sub>     | Initial carrier frequency drift <sup>(1)</sup>               | Integration interval #3 – integration interval #0                            | -19.2 | -    | +19.2 | kHz          |
| IntFreq <sub>drift</sub>   | Intermediate carrier frequency drift <sup>(1)</sup>          | Integration interval #n – integration interval #(n-3), where n=7,8,9k        | -19.2 | -    | +19.2 | kHz          |
| DriftRate <sub>max</sub>   | Maximum drift rate <sup>(1)</sup>                            | Between any two 16-bit groups separated by 48 µs                             | -19.2 | -    | +19.2 | kHz/48<br>μs |
| Z <sub>RF1</sub>           | Optimum RF load<br>(Impedance at RF1 pin)                    | @ 2440 MHz   | -     | 40   | -     | Ω            |

DS14620 - Rev 2 page 27/52



1. Tested according to Bluetooth SIG radio frequency physical layer (RF PHY) test suite (not tested in production).

## 6.3.5 RF receiver characteristics

All performance data are referred to a 50  $\Omega$  antenna connector, via reference design.

Table 20. Bluetooth Low Energy RF receiver characteristics at 1 Msym/s uncoded

| Symbol                     | Parameter  | Test conditions   | Min.               | Тур. | Max. | Unit |
|----------------------------|--|---|--------------------|------|------|------|
| RX <sub>SENS</sub>         | Sensitivity  | PER < 30.8%   | -                  | -97  | -    | dBm  |
| P <sub>SAT</sub>           | Saturation   | PER < 30.8%   | -                  | 8    | -    | dBm  |
| Z <sub>RF1</sub>           | Optimum RF source (impedance at RF1 pin)   | @ 2440 MHz  | -                  | 40   | -    | Ω    |
|                            | RF selectivity with Bluetooth LE equal modulation on interfering signal  |   |                    |      |      |      |
| C/I <sub>CO-channel</sub>  | Co-channel interference $f_{RX} = f_{interference}$  | Wanted signal = -67 dBm, PER < 30.8%                                | -                  | 8    | -    | dBc  |
| C/I <sub>1 MHz</sub>       | Adjacent interference $f_{\text{Interference}} = f_{\text{RX}} \pm 1 \text{ MHz}$ Wanted signal = -67 dBm, PER < 30.8% |   | -                  | -1   | -    | dBc  |
| C/I <sub>2 MHz</sub>       | Adjacent Interference<br>$f_{interference} = f_{RX} \pm 2 \text{ MHz}$   | Wanted signal = -67 dBm, PER < 30.8%                                | -                  | -35  | -    | dBc  |
| C/I <sub>3 MHz</sub>       | Adjacent interference<br>$f_{interference} = f_{RX} \pm (3+n) \text{ MHz}$<br>[n = 0,1,2]                              | Wanted signal = -67 dBm, PER < 30.8%                                |                    | -47  | -    | dBc  |
| C/I <sub>Image</sub>       | C/I $_{Image}$ Image frequency interference $f_{interference} = f_{image}$ Wanted signal = -67 dBm, PER < 30.8%        |   | -                  | -25  | -    | dBc  |
| C/I                        | Adjacent channel-to-image frequency  | Wanted signal= -67 dBm, PER < 30.8%                                 |                    | 25   |      | 40-  |
| C/I <sub>Image±1 MHz</sub> | f <sub>interference</sub> = f <sub>image</sub> ± 1 MHz   |   |                    | -25  | -    | dBc  |
|                            | Out of band block  | king (interfering signal CW)  |                    |      |      |      |
| C/I <sub>Block</sub>       | Interfering signal frequency 30 MHz – 2000 MHz   | Wanted signal = -67 dBm, PER < 30.8%, measurement resolution 10 MHz | -                  | 5    | -    | dB   |
| C/I <sub>Block</sub>       | Interfering signal frequency 2003 MHz – 2399 MHz   | Wanted signal = -67 dBm, PER < 30.8%, measurement resolution 3 MHz  | -                  | -5   | -    | dB   |
| C/I <sub>Block</sub>       | Interfering signal frequency 2484 MHz – 2997 MHz   | Wanted signal = -67 dBm, PER < 30.8%, measurement resolution 3 MHz  | -                  | -5   | -    | dB   |
| C/I <sub>Block</sub>       | Interfering signal frequency 3000 MHz – 12.75 GHz  | Wanted signal = -67 dBm, PER < 30.8%, measurement resolution 25 MHz | -                  | 10   | -    | dB   |
|                            | Intermodulation characteristics (CW s  | ignal at f <sub>1</sub> , Bluetooth LE interfering signal a         | t f <sub>2</sub> ) |      |      |      |
| P_IM(3)                    | Input power of IM interferer at 3 and 6 MHz distance from wanted signal  | Wanted signal = -64 dBm, PER < 30.8%                                | -                  | -27  | -    | dBm  |
| P_IM(-3)                   | Input power of IM interferer at -3 and -6 MHz distance from wanted signal  | Wanted signal = -64 dBm, PER < 30.8%                                | -                  | -40  | -    | dBm  |
| P_IM(4)                    | Input power of IM interferer at ±4 and ±8 MHz distance from wanted signal  | Wanted signal= -64 dBm, PER < 30.8%                                 | -                  | -32  | -    | dBm  |
| P_IM(5)                    | Input power of IM interferer at ±5 and ±10 MHz distance from wanted signal   | Wanted signal = -64 dBm, PER < 30.8%                                | -                  | -32  | -    | dBm  |

DS14620 - Rev 2 page 28/52



Table 21. Bluetooth Low Energy RF receiver characteristics at 2 Msym/s uncoded

| Symbol                     | Parameter   | Test conditions  | Min.               | Тур. | Max. | Unit |
|----------------------------|---|--|--------------------|------|------|------|
| RX <sub>SENS</sub>         | Sensitivity   | PER < 30.8%  | -                  | -94  | -    | dBm  |
| P <sub>SAT</sub>           | Saturation  | PER < 30.8%  |                    | 8    | -    | dBm  |
| Z <sub>RF1</sub>           | Z <sub>RF1</sub> Optimum RF source @ 2440 MHz (impedance at RF1 pin)                                  |  | -                  | 40   | -    | Ω    |
|                            | RF selectivity with Bluetooth LE  | E equal modulation on interfering signal                           |                    |      |      |      |
| C/I <sub>CO-channel</sub>  | Co-channel interference $f_{RX} = f_{interference}$   | Wanted signal= -67 dBm, PER < 30.8%                                | -                  | 8    | -    | dBc  |
| C/I <sub>2 MHz</sub>       | Adjacent interference<br>f <sub>interference</sub> = f <sub>RX</sub> ± 2 MHz                          | Wanted signal = -67 dBm, PER < 30.8%                               | -                  | -14  | -    | dBc  |
| C/I <sub>4 MHz</sub>       | Adjacent interference<br>f <sub>interference</sub> = f <sub>RX</sub> ± 4 MHz                          | Wanted signal = -67 dBm, PER < 30.8%                               | -                  | -41  | -    | dBc  |
| C/I <sub>6 MHz</sub>       | Adjacent interference<br>$f_{interference} = f_{RX} \pm (6+2n) \text{ MHz}$<br>[n = 0,1,2]            | Wanted signal = -67 dBm, PER < 30.8%                               |                    | -45  | -    | dBc  |
| C/I <sub>Image</sub>       | Image frequency interference  finterference = fimage-2M   | Wanted signal = -67 dBm, PER < 30.8%                               |                    | -25  | -    | dBc  |
| C/I <sub>Image±1 MHz</sub> | Adjacent channel-to-image frequency $f_{\text{interference}} = f_{\text{image-2M}} \pm 2 \text{ MHz}$ | Wanted signal= -67 dBm, PER < 30.8%                                | -                  | -14  | -    | dBc  |
|                            | Out of band blocki  | ng (interfering signal CW)   |                    |      |      |      |
| C/I <sub>Block</sub>       | Interfering signal frequency 30 MHz – 2000 MHz  | Wanted signal= -67 dBm, PER < 30.8%, measurement resolution 10 MHz | -                  | 5    | -    | dB   |
| C/I <sub>Block</sub>       | Interfering signal frequency 2003 MHz – 2399 MHz  | Wanted signal= -67 dBm, PER < 30.8%, measurement resolution 3 MHz  | -                  | -5   | -    | dB   |
| C/I <sub>Block</sub>       | Interfering signal frequency 2484 MHz – 2997 MHz  | Wanted signal= -67 dBm, PER < 30.8%, measurement resolution 3 MHz  | -                  | -5   | -    | dB   |
| C/I <sub>Block</sub>       | Interfering signal frequency 3000 MHz – 12.75 GHz   | Wanted signal= -67 dBm, PER < 30.8%, measurement resolution 25 MHz | -                  | 10   | -    | dB   |
|                            | Intermodulation characteristics (CW si  | gnal at f <sub>1</sub> , Bluetooth LE interfering signal a         | t f <sub>2</sub> ) |      |      |      |
| P_IM(6)                    | Input power of IM interferer at 6 and 12 MHz distance from wanted signal                              | Wanted signal= -64 dBm, PER < 30.8%                                | -                  | -27  | -    | dBm  |
| P_IM(-6)                   | Input power of IM interferer at -6 and -12 MHz distance from wanted signal                            | Wanted signal= -64 dBm, PER < 30.8%                                | -                  | -30  | -    | dBm  |
| P_IM(8)                    | Input power of IM interferer at ±8 and ±16 MHz distance from wanted signal                            | Wanted signal= -64 dBm, PER < 30.8%                                | -                  | -30  | -    | dBm  |
| P_IM(10)                   | Input power of IM interferer at ±10 and ±20 MHz distance from wanted signal                           | Wanted signal= -64 dBm, PER < 30.8%                                | -                  | -28  | -    | dBm  |

DS14620 - Rev 2 page 29/52



Table 22. Bluetooth Low Energy RF receiver characteristics at 1 Msym/s LE coded (S=2)

| Symbol                     | Parameter   | Test conditions  | Min. | Тур. | Max. | Unit |  |  |
|----------------------------|---|--|------|------|------|------|--|--|
| RX <sub>SENS</sub>         | Sensitivity   | PER < 30.8%  |      | -100 | -    | dBm  |  |  |
| P <sub>SAT</sub>           | Saturation  | PER < 30.8%  | _    | 8    | -    | dBm  |  |  |
| Z <sub>RF1</sub>           | Optimum RF source<br>(impedance at RF1 pin)   | @ 2440 MHz   |      | 40   | -    | Ω    |  |  |
|                            | RF selectivity with Bluetooth LE equal modulation on interfering signal               |  |      |      |      |      |  |  |
| C/I <sub>CO</sub> -channel | Co-channel interference $f_{RX} = f_{interference}$                                   | Wanted signal = -72 dBm, PER < 30.8%   |      | 2    | -    | dBc  |  |  |
| C/I <sub>1 MHz</sub>       | Adjacent interference<br>$f_{interference} = f_{RX} \pm 1 \text{ MHz}$                | Wanted signal = -72 dBm, PER < 30.8%   |      | -5   | -    | dBc  |  |  |
| C/I <sub>2 MHz</sub>       | Adjacent interference $f_{interference} = f_{RX} \pm 2 \text{ MHz}$                   | Wanted signal = -72 dBm, PER < 30.8%   |      | -38  | -    | dBc  |  |  |
| C/I <sub>3 MHz</sub>       | Adjacent interference $f_{interference} = f_{RX} \pm (3+n) \text{ MHz}$ $[n = 0,1,2]$ | f <sub>interference</sub> = f <sub>RX</sub> ± (3+n) MHz Wanted signal = -72 dBm, PER < 30.8% | _    | -50  | -    | dBc  |  |  |
| C/I <sub>Image</sub>       | Image frequency interference $f_{interference} = f_{image}$                           | Wanted signal = -72 dBm, PER < 30.8%   |      | -30  | -    | dBc  |  |  |
| C/I <sub>Image±1</sub> MHz | Adjacent channel-to-image frequency $f_{interference} = f_{image} \pm 1 \text{ MHz}$  | Wanted signal = -72 dBm, PER < 30.8%   |      | -34  | -    | dBc  |  |  |

Table 23. Bluetooth Low Energy RF receiver characteristics at 1 Msym/s LE coded (S=8)

| Symbol  | Parameter   | Test conditions                      | Min. | Тур. | Max. | Unit |
|---|---|--------------------------------------|------|------|------|------|
| RX <sub>SENS</sub>  | Sensitivity   | PER < 30.8%                          |      | -104 | -    | dBm  |
| P <sub>SAT</sub>  | Saturation  | PER < 30.8%                          | _    | 8    | -    | dBm  |
| Z <sub>RF1</sub>  | Optimum RF source<br>(impedance at RF1 pin)   | @ 2440 MHz                           |      | 40   | -    | Ω    |
| RF selectivity with Bluetooth LE equal modulation on interfering signal |   |                                      |      |      |      |      |
| C/I <sub>CO-channel</sub>   | Co-channel interference $f_{RX} = f_{interference}$                                   | Wanted signal = -72 dBm, PER < 30.8% |      | 1    | -    | dBc  |
| C/I <sub>1 MHz</sub>  | Adjacent interference<br>f <sub>interference</sub> = f <sub>RX</sub> ± 1 MHz          | Wanted signal = -72 dBm, PER < 30.8% |      | -4   | -    | dBc  |
| C/I <sub>2 MHz</sub>  | Adjacent interference<br>f <sub>interference</sub> = f <sub>RX</sub> ± 2 MHz          | Wanted signal = -72 dBm, PER < 30.8% |      | -39  | -    | dBc  |
| C/I <sub>3 MHz</sub>  | Adjacent interference $f_{interference} = f_{RX} \pm (3+n) \text{ MHz}$ $[n = 0,1,2]$ | Wanted signal = -72 dBm, PER < 30.8% | -    | -53  | -    | dBc  |
| C/I <sub>Image</sub>  | Image frequency interference  f <sub>interference</sub> = f <sub>image</sub>          | Wanted signal = -72 dBm, PER < 30.8% |      | -33  | -    | dBc  |
| C/I <sub>Image</sub> ± 1 MHz  | Adjacent channel-to-image frequency $f_{interference} = f_{image} \pm 1 \text{ MHz}$  | Wanted signal = -72 dBm, PER < 30.8% |      | -32  | -    | dBc  |

DS14620 - Rev 2 page 30/52



## 6.3.6 Embedded reset and power control block characteristics

Table 24. Embedded reset and power control block characteristics

| Symbol                | Parameter                                 | Test conditions   | Min. | Тур. | Max. | Unit |
|-----------------------|---|---|------|------|------|------|
| T <sub>RSTTEMPO</sub> | Reset temporization after PDR is detected | V <sub>DD</sub> rising  | -    | -    | 500  | μs   |
| V <sub>PDR</sub>      | Power-down reset threshold                | -   | -    | 1.58 | -    |      |
| V <sub>PVD0</sub>     | PVD0 threshold                            | PVD0 threshold at the falling edge of $V_{DDIO}$                  | -    | 2.05 | -    |      |
| V <sub>PVD1</sub>     | PVD1 threshold                            | PVD1 threshold at the falling edge of V <sub>DDIO</sub>           | -    | 2.21 | -    |      |
| V <sub>PVD2</sub>     | PVD2 threshold                            | PVD2 threshold at the falling edge of V <sub>DDIO</sub>           | -    | 2.36 | -    |      |
| V <sub>PVD3</sub>     | PVD3 threshold                            | PVD3 threshold at the falling edge of V <sub>DDIO</sub>           | -    | 2.53 | -    | V    |
| V <sub>PVD4</sub>     | PVD4 threshold                            | PVD4 threshold at the falling edge of V <sub>DDIO</sub>           | -    | 2.64 | -    |      |
| V <sub>PVD5</sub>     | PVD5 threshold                            | PVD5 threshold at the falling edge of V <sub>DDIO</sub>           | -    | 2.82 | -    |      |
| V <sub>PVD6</sub>     | PVD6 threshold                            | PVD6 threshold at the falling edge of V <sub>DDIO</sub>           | -    | 2.91 | -    |      |
| V <sub>PVD7</sub>     | PVD threshold for V <sub>IN_PVD</sub>     | PVD7 threshold (VBGP) at the falling edge of $V_{\text{IN\_PVD}}$ | -    | 1    | -    |      |

## **6.3.7** Supply current characteristics

The current consumption is a function of several parameters and factors such as: the operating voltage, ambient temperature, I/O pin loading, device software configuration, operating frequencies, I/O pin switching rate, program location in memory and executed binary code.

The MCU is put under the following conditions:

- all I/O pins are in analog input mode
- all peripherals are disabled except when explicitly mentioned
- the flash memory access time is adjusted with the minimum wait states number
- when the peripherals are enabled f<sub>PCLK</sub> = f<sub>HCLK</sub>

Table 25. Current consumption

| Symbol                     | Parameter                                 | Conditions   | Тур.  |       |        | Unit |
|----------------------------|---|--|-------|-------|--------|------|
| Зупівої                    | raiailletei                               | Conditions   | 25 °C | 85 °C | 105 °C |      |
|                            |   | f <sub>HCLK</sub> = 64 MHz<br>All peripherals disabled | 2474  | 2533  | 2580   |      |
| I <sub>DD(Run)</sub>       | Supply current in Run mode <sup>(1)</sup> | f <sub>HCLK</sub> = 32 MHz<br>All peripherals disabled | 1919  | 1980  | 2029   | μA   |
|                            |   | f <sub>HCLK</sub> = 16 MHz<br>All peripherals disabled | 1576  | 1632  | 1678   |      |
|                            |   | Clock OFF  | 654   | 3930  | 8870   |      |
| I <sub>DD(Deepstop)</sub>  | Supply current in Deepstop <sup>(2)</sup> | Clock source LSI                                       | 1214  | 4556  | 9530   | nA   |
| I <sub>DD</sub> (Shutdown) |   | Clock source LSE                                       | 991   | 4828  | 10596  |      |
|                            | Supply current in Shutdown                | -  | 15    | 350   | 1090   |      |
| I <sub>DD</sub> (RST)      | Current under reset condition             | -  | 1098  | 1160  | 1230   | μA   |

<sup>1.</sup> CPU executes a "while(1)" loop

DS14620 - Rev 2 page 31/52

<sup>2.</sup> The current consumption in Deepstop mode is measured considering the entire SRAM retained.

### 6.3.8 Wake up time from low power modes

The wake up times reported are the latency between the event and the execution of the instruction. The device goes to low-power mode after WFI (wait for interrupt) instructions.

Table 26. Low power mode wake up timing

| Symbol Parameter |                         | Parameter                                   | Conditions                                      | Тур. | Unit |
|------------------|-------------------------|---|---|------|------|
|                  | T <sub>WUDEEPSTOP</sub> | Wake up time from Deepstop mode to Run mode | Wake up from GPIO $V_{DD}$ = 3.3 V flash memory | 170  | μs   |

## 6.3.9 High speed crystal requirements

The high speed external oscillator must be supplied with an external 32 MHz crystal that is specified for a 6 to 8 pF loading capacitor. The STM32WB05xN includes internal programmable capacitances that can be used to tune the crystal frequency in order to compensate the PCB parasitic one. These internal load capacitors are made by a fixed one, in parallel with a 6-bit binary weighted capacitor bank. Thanks to low CL step size (1-bit is typically 0.07 pF), very fine crystal tuning is possible. With a typical crystal sensitivity of -14 ppm/pF, it is possible to trim a 32 MHz crystal, with a resolution of 1 ppm.

The requirements for the external 32 MHz crystal are reported in the table below.

Table 27. HSE crystal requirements

| Symbol           | Parameter                                | Conditions   | Min.             | Тур.             | Max.               | Unit |
|------------------|--|--|------------------|------------------|--------------------|------|
| f <sub>NOM</sub> | Oscillator frequency                     | -  | -                | 32               | -                  | MHz  |
| f <sub>TOL</sub> | Frequency tolerance                      | Includes initial accuracy, stability over temperature, aging and frequency pulling due to incorrect load capacitance | -                | -                | ±50                | ppm  |
| ESR              | Equivalent series resistance             | -  | -                | -                | 100                | Ω    |
| P <sub>D</sub>   | Drive level                              | -  | -                | -                | 100                | μW   |
| CL               | HSE crystal load capacitance             | 27 °C, typical corner<br>GMCONF = 3  | 5 <sup>(1)</sup> | 7 <sup>(2)</sup> | 9.2 <sup>(3)</sup> | pF   |
| CLstep           | HSE crystal load capacitance 1-bit value | 27 °C,<br>GMCONF = 3<br>XOTUNE code between 32 and 33  | -                | 0.07             | -                  | pF   |

- 1. XOTUNE programed at minimum code = 0
- 2. XOTUNE programed at center code = 32
- 3. XOTUNE programed at maximum code = 63

### 6.3.10 Low speed crystal requirements

Low speed clock can be supplied with an external 32.768 kHz crystal oscillator. Requirements for the external 32.768 kHz crystal are reported in the table below.

Table 28. LSE crystal requirements

| Symbol                | Parameter                               | Conditions                                    | Min. | Тур.   | Max. | Unit |
|-----------------------|---|---|------|--------|------|------|
| f <sub>NOM</sub>      | Nominal frequency                       | -   | -    | 32.768 | -    | kHz  |
| ESR                   | Equivalent series resistance            | -   | -    | -      | 90   | kΩ   |
| $P_{D}$               | Drive level                             | -   | -    | -      | 0.1  | μW   |
| 0                     | Marina anii al anatal a                 | LSEDRV[1:0] = 00  Low drive capability        | -    | -      | 0.50 |      |
| G <sub>mcritmax</sub> | Maximum critical crystal g <sub>m</sub> | LSEDRV[1:0] = 01  Medium low drive capability | -    | -      | 0.75 | μA/V |

DS14620 - Rev 2 page 32/52



| Symbol                | Parameter                               | Conditions                                     | Min. | Тур. | Max. | Unit   |
|-----------------------|---|--|------|------|------|--------|
| G <sub>mcritmax</sub> | Maximum critical crystal g <sub>m</sub> | LSEDRV[1:0] = 10  Medium high drive capability | -    | -    | 1.70 | uA/V   |
| Onichimax             | marmam enasar eryetar gili              | LSEDRV[1:0] = 11 High drive capability         |      | -    | 2.70 | μ, σ σ |

## 6.3.11 High speed ring oscillator characteristics

Table 29. HSI oscillator characteristics

| Symbol           | Parameter         | Conditions | Min. | Тур. | Max. | Unit |
|------------------|-------------------|------------|------|------|------|------|
| f <sub>NOM</sub> | Nominal frequency | -          | -    | 64   | -    | MHz  |

## 6.3.12 Low speed ring oscillator characteristics

Table 30. LSI oscillator characteristics

|                                    | Symbol                          | Parameter                        | Conditions         | Min. | Тур. | Max. | Unit   |
|------------------------------------|---------------------------------|----------------------------------|--------------------|------|------|------|--------|
| f <sub>NOM</sub> Nominal frequency |                                 | -                                | -                  | 33   | -    | kHz  |        |
|                                    | $\Delta F_{RO}\Delta T}/F_{RO}$ | Frequency spread vs. temperature | Standard deviation | -    | 140  | -    | ppm/°C |

#### 6.3.13 PLL characteristics

Characteristics measured over recommended operating conditions unless otherwise specified.

**Table 31. PLL characteristics** 

| Symbol                   | Parameter              | Conditions  | Min. | Тур. | Max. | Unit   |
|--------------------------|------------------------|---|------|------|------|--------|
| PN <sub>SYNTH</sub>      |                        | At ±1 MHz offset from carrier (measured at 2.4 GHz)         | -    | -110 | -    | dBc/Hz |
|                          | RF carrier phase noise | At 2.4 GHz ±3 MHz offset from carrier (measured at 2.4 GHz) | 114  | -114 | -    | dBc/Hz |
|                          |                        | At 2.4 GHz±6 MHz offset from carrier (measured at 2.4 GHz)  |      | -128 | -    | dBc/Hz |
|                          |                        | At ±25 MHz offset from carrier                              | -    | -135 | -    | dBc/Hz |
| LOCK <sub>TIMETX</sub>   | PLL lock time to TX    | With calibration @2.5 ppm                                   | -    | 150  | -    | μs     |
| LOCK <sub>TIMERX</sub>   | PLL lock time to RX    | With calibration @2.5 ppm                                   | -    | 110  | -    | μs     |
| LOCK <sub>TIMERXTX</sub> | PLL lock time RX to TX | Without calibration @2.5 ppm                                | -    | 47   | -    | μs     |
| LOCK <sub>TIMETXRX</sub> | PLL lock time TX to RX | Without calibration @2.5 ppm                                | -    | 32   | -    | μs     |

## 6.3.14 Electrostatic discharge (ESD)

Electrostatic discharges (a positive then a negative pulse separated by 1 second) are applied to the pins of each sample according to each pin combination. The sample size depends on the number of supply pins in the device (3 parts x (n + 1) supply pins). This test conforms to the ANSI/JEDEC standard.

DS14620 - Rev 2 page 33/52



| Symbol               | Parameter   | Conditions                                 |     | Max. <sup>(1)</sup> | Unit |
|----------------------|---|--|-----|---------------------|------|
| V <sub>ESD(HBN</sub> | Electrostatic discharge voltage (human body model)    | Conforming to ANSI/ESDA/JEDEC JS-001       | 2   | 2000                | V    |
| V <sub>ESD(CBN</sub> | Electrostatic discharge voltage (charge device model) | Conforming to ANSI/ESDA/STM5.3.1<br>JS-002 | C2a | 500                 | V    |

<sup>1.</sup> Guaranteed by design.

## 6.3.15 I/O port characteristics

Unless otherwise specified, the parameters given in the tables below are derived from tests performed under the conditions summarized in Table 15. General operating conditions. All I/Os are designed as CMOS-compliant.

Table 33. I/O static characteristics

| Symbol                                 | Parameter                    | Conditions   | Min.                  | Тур. | Max.                  | Unit |
|--|------------------------------|--|-----------------------|------|-----------------------|------|
| V <sub>IL</sub>                        | I/O input low level voltage  | 1.62 V < V <sub>DD</sub> < 3.6 V                             | -                     | -    | 0.3 x V <sub>DD</sub> | V    |
| V <sub>IH</sub>                        | I/O input high level voltage | 1.02 V \ V <sub>DD</sub> \ 3.0 V                             | 0.7 x V <sub>DD</sub> | -    | -                     | V    |
|  |                              | $0 \le V_{IN} \le Max(V_{DDx})^{(1)}$                        | -                     | -    | +/-100                |      |
| I <sub>lkg</sub> Input leakage current | Input leakage current        | $Max(V_{DDx})^{(1)} \le V_{IN} \le Max(V_{DDx})^{(1)} + 1 V$ | -                     | -    | 650                   | nA   |
|  |                              | $Max(V_{DDx})^{(1)} + 1 V < V_{IN} \le 5.5 V$                | -                     | -    | 200                   |      |
| R <sub>PU</sub>                        | Pull-up resistor             | V <sub>IN</sub> = GND  | 25                    | 40   | 55                    | kΩ   |
| R <sub>PD</sub>                        | Pull-down resistor           | V <sub>IN</sub> = VDD  | 25                    | 40   | 55                    | K12  |
| C <sub>IO</sub>                        | I/O pin capacitance          | -  | -                     | 5    | -                     | pF   |

<sup>1.</sup>  $Max(V_{DDx})$  is the maximum value among all the I/O supplies.

All I/Os are CMOS-compliant (no software configuration required).

GPIOs (general purpose input/outputs) can sink or source up to  $\pm 8$  mA and sink or source up to  $\pm 20$  mA (with a relaxed  $V_{OL}$  /  $V_{OH}$ ).

In the user application, the number of I/O pins that can drive current must be limited to respect the absolute maximum rating specified.

- The sum of currents sourced by all I/Os on VDD, plus the maximum consumption of MCU sourced on VDD, cannot exceed the absolute maximum rating ΣIVDD
- The sum of currents sunk by all I/Os on VSS, plus the maximum consumption of the MCU sunk on GND, cannot exceed the absolute maximum rating <code>\SigmaIVGND</code>.

Table 34. Output voltage characteristics

| Symbol          | Parameter                             | Conditions  | Min.     | Max. | Unit |
|-----------------|---------------------------------------|---|----------|------|------|
| V <sub>OL</sub> | Output low level voltage for I/O pin  | CMOS port <sup>(1)</sup>  IIO  = 8 mA VDD ≥ 2.7 V | -        | 0.4  |      |
| V <sub>OH</sub> | Output high level voltage for I/O pin | GWOS PORTY INOT - 8 HIM VDD 2 2.7 V               | VDD -0.4 | -    |      |
| V <sub>OL</sub> | Output low level voltage for I/O pin  | IIO  = 20 mA VDD ≥ 2.7 V                          | -        | 1.3  | V    |
| V <sub>OH</sub> | Output high level voltage for I/O pin |   | VDD -1.3 | -    | V    |
| V <sub>OL</sub> | Output low level voltage for I/O pin  | IIO  = 4 mA VDD ≥ 1.62 V                          | -        | 0.4  |      |
| V <sub>OH</sub> | Output high level voltage for I/O pin |   | VDD-0.45 | -    |      |

<sup>1.</sup> CMOS outputs are compatible with JEDEC standards JESD36 and JESD52.

DS14620 - Rev 2 page 34/52



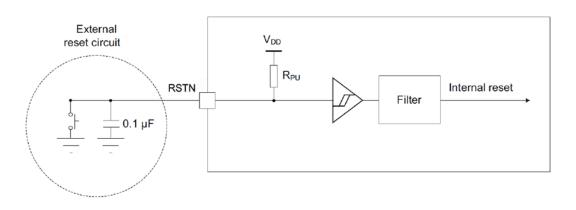
## 6.3.16 RSTN pin characteristics

The RSTN pin input driver uses CMOS technology. It is connected to a permanent pull-up resistor, RPU. Unless otherwise specified, the parameters given in the table below are derived from tests performed under the ambient temperature and supply voltage conditions summarized in Section 6.3.2: General operating conditions.

Table 35. RSTN pin characteristics

| Symbol                 | Parameter                               | Test conditions      | Min.                  | Тур. | Max.                  | Unit. |
|------------------------|---|----------------------|-----------------------|------|-----------------------|-------|
| V <sub>IL(RSTN)</sub>  | RSTN input low level voltage            | -                    | -                     | -    | 0.3 x V <sub>DD</sub> | V     |
| V <sub>IH(RSTN)</sub>  | RSTN input high level voltage           | -                    | 0.7 x V <sub>DD</sub> | -    | -                     | , v   |
| V <sub>hys(RSTN)</sub> | RSTN Schmitt trigger voltage hysteresis | -                    | -                     | 200  | -                     | mV    |
| RPU                    | Weak pull-up equivalent resistor        | V <sub>IN</sub> =GND | 25                    | 40   | 55                    | kΩ    |

Figure 9. Recommended RSTN pin protection



Note:

The external reset circuit protects the device against parasitic resets.

The user must ensure that the level on the RSTN pin can go below the  $V_{IL}$ (RSTN) max. level specified in the table, otherwise the reset is not taken into account by the device. The external capacitor on RSTN must be placed as close as possible to the device.

## 6.3.17 SPI characteristics

The parameters for SPI are derived from tests performed according to f<sub>PCLKx</sub> frequency and supply voltage conditions summarized in Table 15. General operating conditions.

- Output speed is set to OSPEEDRy[1:0] = 11
- Capacitive load C = 30 pF
- Measurement points are done at CMOS levels: 0.5 x V<sub>DD</sub>

Table 36. SPI characteristics

| Symbol             | Parameter             | Conditions  | Min.                        | Тур.                  | Max.                     | Units |
|--------------------|-----------------------|-------------|-----------------------------|-----------------------|--------------------------|-------|
| f                  | CDI alask fraguensy   | Master mode |                             | 32                    | MHz                      |       |
| f <sub>SCK</sub>   | SPI clock frequency   | Slave mode  | -                           | -                     | 32 <sup>(1)</sup>        | IVITZ |
| tsu(NSS)           | NSS setup time        | -           | 4 / f <sub>PCLK</sub>       | -                     | -                        | -     |
| th(NSS)            | NSS hold time         | -           | 2 / f <sub>PCLK</sub>       | -                     | -                        | -     |
| tw(SCKH), tw(SCKL) | SCK high and low time | Master mode | 1 / f <sub>PCLK</sub> - 1.5 | 1 / f <sub>PCLK</sub> | 1 / f <sub>PCLK</sub> +1 | ns    |

DS14620 - Rev 2 page 35/52

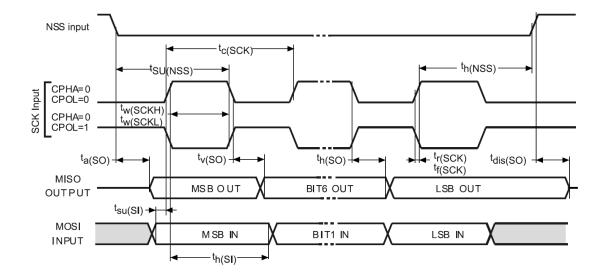
DT57475V1



| Symbol               | Parameter                | Conditions  | Min. | Тур. | Max. | Units |
|----------------------|--------------------------|-------------|------|------|------|-------|
| tsu(MI)              | Data input set-up time   | Master mode | 2    | -    | -    |       |
| tsu(SI)              | Data input set-up time   | Slave mode  | 1    | -    | -    |       |
| th(MI)               | Data input hold time     | Master mode | 2    | -    | -    |       |
| th(SI)               | Data input hold time     | Slave mode  | 0    | -    | -    |       |
| t <sub>a(SO)</sub>   | Data output access time  | Slave mode  | 6    | -    | 30   |       |
| t <sub>dis(SO)</sub> | Data output disable time | Slave mode  | 6    | -    | 32   | ns    |
| t <sub>v(MO)</sub>   | Data output valid time   | Master mode | -    | 5    | 9    |       |
| t <sub>v(SO)</sub>   | Data output valid time   | Slave mode  | -    | 12   | 35   |       |
| t <sub>h(MO)</sub>   | Data autout bald time    | Master mode | 1    | -    |      |       |
| t <sub>h(SO)</sub>   | Data output hold time    | Slave mode  | 6    | -    | _    |       |

The maximum frequency in slave transmitter mode is determined by the sum of tv(SO) and tsu(MI), which has to fit SCK low or high phase preceding the SCK sampling edge. This value can be achieved when the SPI communicates with a master having tsu(MI) = 0 while duty(SCK) = 50 %.

Figure 10. SPI timing diagram - slave mode and CPHA = 0



DT57476V1

DS14620 - Rev 2 page 36/52

Figure 11. SPI timing diagram - slave mode and CPHA = 1

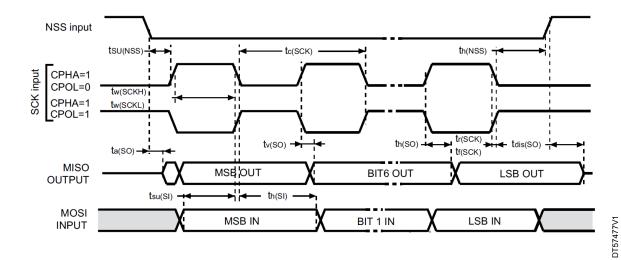
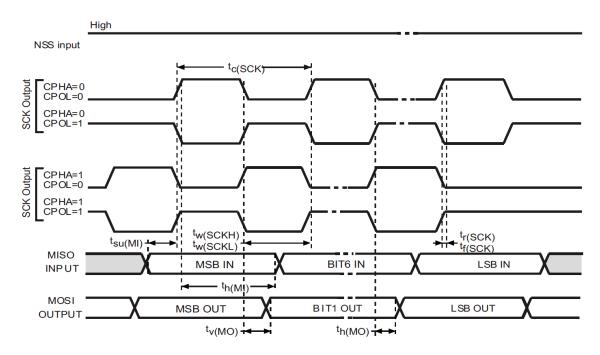


Figure 12. SPI timing diagram - master mode



DT57478V1

DS14620 - Rev 2 page 37/52



### 7 Package information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK packages, depending on their level of environmental compliance. ECOPACK specifications, grade definitions and product status are available at: www.st.com. ECOPACK is an ST trademark.

#### 7.1 Device marking

Refer to technical note "Reference device marking schematics for STM32 microcontrollers and microprocessors" (TN1433) available on http://www.st.com. This note provides information on the location of pin 1 / ball A1 and the location and orientation of the marking areas relative to pin 1 / ball A1.

Parts marked as ES, E, or accompanied by an engineering sample notification letter are not yet qualified and therefore not approved for use in production. ST is not responsible for any consequences resulting from such use. In no event, STMicroelectronics is liable for the customer using any of these engineering samples in production. STMicroelectronics quality department must be contacted prior to any decision to use these engineering samples to run a qualification activity.

A WLCSP simplified marking example is provided in the corresponding package information subsection.

DS14620 - Rev 2 page 38/52



### 7.2 VFQFPN32 package information (42)

This VFQFPN is a 32 lead, 5 x 5 mm, 0.50 mm pitch, very fine pitch quad flat no lead package.

SEATING PLANE

C

A3

SIDE VIEW

D

PIN #1 ID
CHAMFER 0.35

BOTTOM VIEW

Figure 13. VFQFPN32 - Outline

- 1. Drawing is not to scale.
- 2. Package outline exclusive of any mold flashes dimensions and metal burrs.
- 3. Details of terminal 1 are optional but must be located on the top surface of the package by using either a mold or marked features.

42\_VFQFPN32\_CALAMBA\_ME\_V1

DS14620 - Rev 2

0.0020



| Symbol           | Millimetres |      |      | Inches <sup>(1)</sup> |        |        |
|------------------|-------------|------|------|-----------------------|--------|--------|
| Symbol           | Min         | Тур  | Max  | Min                   | Тур    | Max    |
| A <sup>(2)</sup> | 0.80        | 0.90 | 1.00 | 0.0315                | 0.0354 | 0.0394 |
| A1               | 0           | -    | 0.05 | 0                     | -      | 0.0020 |
| A3               | -           | 0.20 | -    | -                     | 0.008  | -      |
| b                | 0.18        | 0.25 | 0.30 | 0.0070                | 0.0098 | 0.0118 |
| D                | 4.90        | 5.00 | 5.10 | 0.1929                | 0.19   | 0.2008 |
| Е                | 4.90        | 5.00 | 5.10 | 0.1929                | 0.19   | 0.2008 |
| D2               | 3.60        | 3.70 | 3.80 | 0.1417                | 0.1457 | 0.1496 |
| E2               | 3.60        | 3.70 | 3.80 | 0.1417                | 0.1457 | 0.1496 |
| е                | -           | 0.50 | -    | -                     | 0.0197 | -      |
| L                | 0.30        | 0.40 | 0.50 | 0.0118                | 0.0157 | 0.0197 |

Table 37. VFQFPN32 - Mechanical data

1. Values in inches are converted from mm and rounded to 3 decimal digits.

ddd

VFQFPN stands for thermally Enhanced very thin fine pitch quad flat package No lead. Very thin profile 0.80 < A ≤ 1.00 mm.</li>

0.05

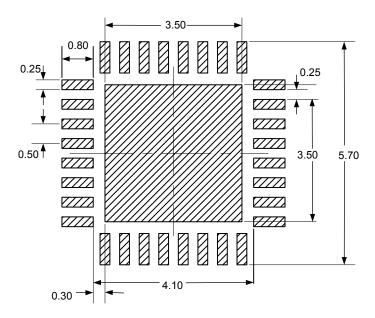


Figure 14. VFQFPN32 - Footprint example

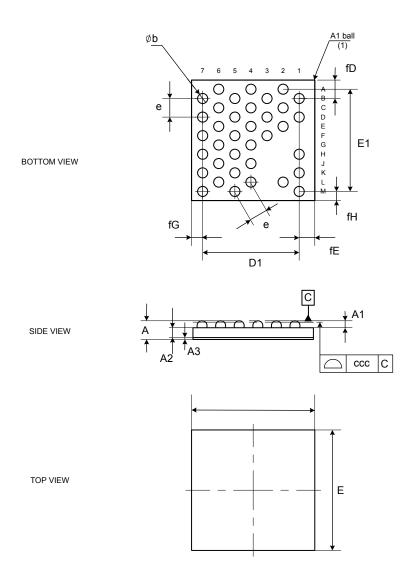
42\_VFQFPN32\_CALAMBA\_FP\_V1



### 7.3 WLCSP36 package information (01C1)

This WLCSP is a 36-ball, 2.652 x 2.592 mm, 0.40 mm pitch, wafer level chip scale array package.

Figure 15. WLCSP36 - Outline



 The terminal A1 on the bumps side is identified by a distinguishing feature (for instance by a circular "clear area" - typically 0.1 mm diameter) and/or a missing bump.
 The terminal A1 on the backside of the product is identified by a distinguishing feature (for instance by a circular "clear area" - typically 0.5 mm diameter).

2. Drawing is not to scale.

01C1\_WLCSP36\_ME\_V1

DS14620 - Rev 2

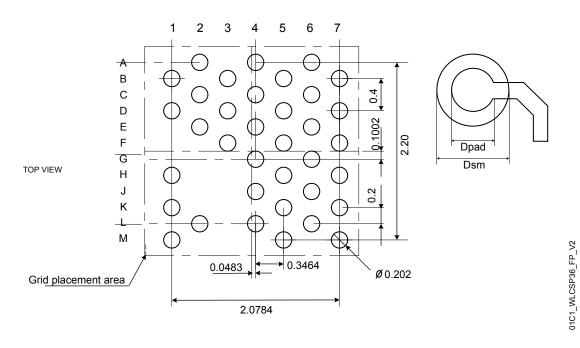


Table 38. WLCSP36 - Mechanical data

| Symbol | millimeters |       |       | inches <sup>(1)</sup> |        |        |
|--------|-------------|-------|-------|-----------------------|--------|--------|
| Symbol | Min         | Тур   | Max   | Min                   | Тур    | Max    |
| А      | -           | -     | 0.422 | -                     | -      | 0.0166 |
| A1     | 0.135       | -     | -     | 0.0053                | -      | -      |
| A2     | -           | 0.225 | -     | -                     | 0.0088 | -      |
| A3     | -           | 0.025 | -     | -                     | 0.0010 | -      |
| b      | 0.193       | 0.218 | 0.243 | 0.0076                | 0.0085 | 0.0096 |
| D      | -           | 2.652 | -     | -                     | 0.1044 | -      |
| D1     | -           | 2.078 | -     | -                     | 0.0818 | -      |
| E      | -           | 2.592 | -     | -                     | 0.1020 | -      |
| E1     | -           | 2.200 | -     | -                     | 0.0866 | -      |
| е      | -           | 0.40  | -     | -                     | 0.0157 | -      |
| fD     | -           | 0.397 | -     | -                     | 0.0156 | -      |
| fE     | -           | 0.335 | -     | -                     | 0.0132 | -      |
| fG     | -           | 0.239 | -     | -                     | 0.0094 | -      |
| fH     | -           | 0.196 | -     | -                     | 0.0077 | -      |
| ccc    | -           | 0.030 | -     | -                     | 0.0012 | -      |

<sup>1.</sup> Values in inches are converted from mm and rounded to 4 decimal digits.

Figure 16. WLCSP36 - Footprint example



1. Dimensions are expressed in millimeters.

DS14620 - Rev 2 page 42/52



| Dimension         | Values   |
|-------------------|--|
| Pitch             | 0.4 mm   |
| Dpad              | 0.225 mm   |
| Dsm               | 0.290 mm typ. (depends on soldermask registration tolerance) |
| Stencil opening   | 0.250 mm   |
| Stencil thickness | 0.100 mm   |

Table 39. WLCSP36 - Example of PCB design rules

#### 7.3.1 Device marking example for WLCSP36

The following figure gives an example of topside marking versus pin 1 position identifier location. The printed markings may differ depending on the supply chain. Other optional marking or inset/upset marks, which depend on supply chain operations, are not indicated below.

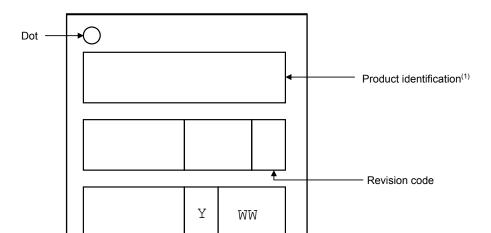


Figure 17. WLCSP36 marking example (package top view)

Parts marked as "ES", "E" or accompanied by an engineering sample notification letter, are not yet qualified
and therefore not approved for use in production. ST is not responsible for any consequences resulting from
such use. In no event will ST be liable for the customer using any of these engineering samples in production.
ST's Quality department must be contacted prior to any decision to use these engineering samples to run a
qualification activity.

#### 7.4 Thermal characteristics

The maximum chip junction temperature ( $T_{Jmax.}$ ) must never exceed the values in general operating conditions. The maximum chip-junction temperature,  $T_{J}$  max., in degrees Celsius, can be calculated using the equation:

$$T_{I}\max. = T_{A}\max. + (PD\max \times \theta JA) \tag{1}$$

Date code

where:

- T<sub>A</sub> max. is the maximum ambient temperature in °C
- Θ<sub>JA</sub> is the package junction-to-ambient thermal resistance, in °C/W
- PD max. is the sum of PINT max. and PI/O max. (PD max. = PINT max. + PI/O max.)
- PINT max. is the product of I<sub>DD</sub> and V<sub>DD</sub>, expressed in Watts. This is the maximum chip internal power
   PI/O max represents the maximum power dissipation on output pins:
- PI/O max. =  $\Sigma (V_{OL} \times I_{OL}) + \Sigma ((V_{DD} V_{OH}) \times I_{OH})$

taking into account the actual  $V_{OL}$  /  $I_{OL}$  and  $V_{OH}$  /  $I_{OH}$  of the I/Os at low and high level in the applications.

DS14620 - Rev 2 page 43/52



Note: When the SMPS is used, a portion of the power consumption is dissipated into the external inductor, therefore

reducing the chip power dissipation. This portion depends mainly on the inductor ESR characteristics.

Note: As the radiated RF power is quite low (< 4 mW), it is not necessary to remove it from the chip power

consumption.

Note: RF characteristics (such as: sensitivity, Tx power, consumption) are provided up to 85 °C.

Table 40. Package thermal characteristics

| Symbol | Parameter  | Value | Unit |
|--------|--|-------|------|
| ОЈА    | Thermal resistance junction-ambient VFQFPN32 - 5 mm x 5 mm |       | °C/W |
| OJA    | Thermal resistance junction-ambient WLCSP36 - 0.4 mm pitch | _(1)  | C/VV |

1. Not yet available.

DS14620 - Rev 2 page 44/52



# 8 Ordering information

Table 41. Ordering information scheme



TR = tape and reel

1. ECOPACK2 (RoHS compliant and free of brominated, chlorinated and antimony oxide flame retardants).

Note:

For a list of available options (memory, package, and so on) or for further information on any aspect of this device, contact your nearest ST sales office.

DS14620 - Rev 2 page 45/52



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DS14620 - Rev 2 page 46/52



# **Revision history**

Table 42. Document revision history

| Date        | Version | Changes                   |
|-------------|---------|---------------------------|
| 17-Jun-2024 | 1       | Initial release.          |
| 26-Jun-2024 | 2       | Updated various sections. |

DS14620 - Rev 2 page 47/52



# **Contents**

| 1 | Intro | ductior                               | 1   | 3  |  |  |  |
|---|-------|---------------------------------------|---|----|--|--|--|
| 2 | Desc  | cription                              |   |    |  |  |  |
| 3 | Func  | tional                                | overview  | 6  |  |  |  |
|   | 3.1   | Arm C                                 | ortex-M0+ core with MPU                                   | 6  |  |  |  |
|   | 3.2   | RF sub                                | osystem   | 6  |  |  |  |
|   |       | 3.2.1                                 | RF front-end block diagram                                | 6  |  |  |  |
|   |       | 3.2.2                                 | IPDs for STM32WB05xN                                      | 7  |  |  |  |
|   | 3.3   | Power                                 | supply management   | 8  |  |  |  |
|   |       | 3.3.1                                 | SMPS step-down regulator                                  | 8  |  |  |  |
|   |       | 3.3.2                                 | Power supply schemes                                      | 8  |  |  |  |
|   |       | 3.3.3                                 | Linear voltage regulators                                 | 8  |  |  |  |
|   |       | 3.3.4                                 | Power supply supervisor                                   | 9  |  |  |  |
|   | 3.4   | Reset                                 | management  | 9  |  |  |  |
|   | 3.5   | Operat                                | ting modes  | 9  |  |  |  |
|   |       | 3.5.1                                 | Run mode  | 10 |  |  |  |
|   |       | 3.5.2                                 | Deepstop mode   | 10 |  |  |  |
|   |       | 3.5.3                                 | Shutdown mode   | 11 |  |  |  |
|   | 3.6   | Clock                                 | management  | 11 |  |  |  |
|   | 3.7   | General purpose inputs/outputs (GPIO) |   |    |  |  |  |
|   | 3.8   | .8 Direct memory access (DMA)         |   |    |  |  |  |
|   | 3.9   | Nestec                                | d vectored interrupt controller (NVIC)                    | 12 |  |  |  |
|   | 3.10  | Univer                                | sal synchronous/asynchronous receiver transmitter (USART) | 12 |  |  |  |
|   | 3.11  | Serial                                | peripheral interface (SPI)                                | 13 |  |  |  |
|   | 3.12  | Serial                                | wire debug port   | 13 |  |  |  |
|   | 3.13  | TX and                                | d RX event alert  | 13 |  |  |  |
|   | 3.14  | Directi                               | on finding  | 13 |  |  |  |
| 4 | Pino  |                                       | l pin description   |    |  |  |  |
| 5 |       |                                       | circuits  |    |  |  |  |
| 6 | • • • |                                       | naracteristics  |    |  |  |  |
|   | 6.1   |                                       | eter conditions   |    |  |  |  |
|   | 0.1   | 6.1.1                                 | Minimum and maximum values                                |    |  |  |  |
|   |       | 6.1.2                                 | Typical values  |    |  |  |  |
|   |       | 6.1.3                                 | Typical curves  |    |  |  |  |
|   |       | 6.1.4                                 | Loading capacitor   |    |  |  |  |
|   |       | 6.1.5                                 | Pin input voltage   |    |  |  |  |



|     | 6.2    | Absolu   | ıte maximum ratings                                    | 22 |
|-----|--------|----------|--|----|
|     | 6.3    | Operat   | ting conditions  | 23 |
|     |        | 6.3.1    | Summary of main performance                            | 23 |
|     |        | 6.3.2    | General operating conditions                           | 25 |
|     |        | 6.3.3    | RF general characteristics                             | 26 |
|     |        | 6.3.4    | RF transmitter characteristics                         | 26 |
|     |        | 6.3.5    | RF receiver characteristics                            | 28 |
|     |        | 6.3.6    | Embedded reset and power control block characteristics | 31 |
|     |        | 6.3.7    | Supply current characteristics                         | 31 |
|     |        | 6.3.8    | Wake up time from low power modes                      | 32 |
|     |        | 6.3.9    | High speed crystal requirements                        | 32 |
|     |        | 6.3.10   | Low speed crystal requirements                         | 32 |
|     |        | 6.3.11   | High speed ring oscillator characteristics             | 33 |
|     |        | 6.3.12   | Low speed ring oscillator characteristics              | 33 |
|     |        | 6.3.13   | PLL characteristics                                    | 33 |
|     |        | 6.3.14   | Electrostatic discharge (ESD)                          | 33 |
|     |        | 6.3.15   | I/O port characteristics                               | 34 |
|     |        | 6.3.16   | RSTN pin characteristics                               | 35 |
|     |        | 6.3.17   | SPI characteristics                                    | 35 |
| 7   | Pack   | age inf  | formation  | 38 |
|     | 7.1    | Device   | e marking  | 38 |
|     | 7.2    | VFQFF    | PN32 package information (42)                          | 39 |
|     | 7.3    | WLCSI    | P36 package information (01C1)                         | 41 |
|     |        | 7.3.1    | Device marking example for WLCSP36                     | 43 |
|     | 7.4    | Therma   | al characteristics                                     | 43 |
| 8   | Orde   | ring inf | formation  | 45 |
| lmp | ortant | securit  | ty notice  | 46 |
| Rev | vision | history  |  | 47 |
|     |        | -        |  |    |
|     |        |          |  |    |
|     |        |          |  |    |



# **List of tables**

| Table 1.  | STM32WB05xx device features and peripheral counts  | . 5 |
|-----------|--|-----|
| Table 2.  | IPDs for STM32WB05xN   |     |
| Table 3.  | Relationship between the low power modes and functional blocks                             | 10  |
| Table 4.  | Pin descriptions   | 16  |
| Table 5.  | Legend/abbreviations used in the pinout table  |     |
| Table 6.  | Alternate function port A  | 18  |
| Table 7.  | Alternate function port B  | 18  |
| Table 8.  | Application circuit external components  | 20  |
| Table 9.  | Voltage characteristics  | 22  |
| Table 10. | Current characteristics  | 22  |
| Table 11. | Thermal characteristics  | 23  |
| Table 12. | Main performance SMPS ON   | 23  |
| Table 13. | Main performance SMPS bypassed   |     |
| Table 14. | Peripheral current consumption at V <sub>DD</sub> = 3.3 V, system clock (CLK_SYS), SMPS on | 24  |
| Table 15. | General operating conditions   | 25  |
| Table 16. | Bluetooth Low Energy RF general characteristics  | 26  |
| Table 17. | Bluetooth Low Energy RF transmitter characteristics at 1 Mbps not coded                    | 26  |
| Table 18. | Bluetooth Low Energy RF transmitter characteristics at 2 Mbps not coded                    | 27  |
| Table 19. | Bluetooth Low Energy RF transmitter characteristics at 1 Mbps LE coded (S=8)               | 27  |
| Table 20. | Bluetooth Low Energy RF receiver characteristics at 1 Msym/s uncoded                       | 28  |
| Table 21. | Bluetooth Low Energy RF receiver characteristics at 2 Msym/s uncoded                       | 29  |
| Table 22. | Bluetooth Low Energy RF receiver characteristics at 1 Msym/s LE coded (S=2)                | 30  |
| Table 23. | Bluetooth Low Energy RF receiver characteristics at 1 Msym/s LE coded (S=8)                | 30  |
| Table 24. | Embedded reset and power control block characteristics                                     | 31  |
| Table 25. | Current consumption  | 31  |
| Table 26. | Low power mode wake up timing  | 32  |
| Table 27. | HSE crystal requirements   | 32  |
| Table 28. | LSE crystal requirements   | 32  |
| Table 29. | HSI oscillator characteristics   | 33  |
| Table 30. | LSI oscillator characteristics   | 33  |
| Table 31. | PLL characteristics  | 33  |
| Table 32. | ESD absolute maximum ratings   | 34  |
| Table 33. | I/O static characteristics   | 34  |
| Table 34. | Output voltage characteristics   | 34  |
| Table 35. | RSTN pin characteristics   | 35  |
| Table 36. | SPI characteristics  | 35  |
| Table 37. | VFQFPN32 - Mechanical data   | 40  |
| Table 38. | WLCSP36 - Mechanical data  | 42  |
| Table 39. | WLCSP36 - Example of PCB design rules  | 43  |
| Table 40. | Package thermal characteristics  | 44  |
| Table 41. | Ordering information scheme  | 45  |
| Table 42. | Document revision history  | 47  |

DS14620 - Rev 2 page 50/52



# **List of figures**

| Figure 1.  | STM32WB05xN RF block diagram                           | . 7 |
|------------|--|-----|
| Figure 2.  | Power supply configuration                             | . 8 |
| Figure 3.  | Pinout top view (VFQFPN32 package)                     | 14  |
| Figure 4.  | Pinout bump side view (WLCSP36 package)                | 15  |
| Figure 5.  | Application circuit: DC-DC converter, WLCSP36 package  | 19  |
| Figure 6.  | Application circuit: DC-DC converter, VFQFPN32 package | 19  |
| Figure 7.  | Pin loading conditions                                 | 21  |
| Figure 8.  | Pin input voltage                                      | 22  |
| Figure 9.  | Recommended RSTN pin protection                        | 35  |
| Figure 10. | SPI timing diagram - slave mode and CPHA = 0           | 36  |
| Figure 11. | SPI timing diagram - slave mode and CPHA = 1           | 37  |
| Figure 12. | SPI timing diagram - master mode                       | 37  |
| Figure 13. | VFQFPN32 - Outline                                     |     |
| Figure 14. | VFQFPN32 - Footprint example                           | 40  |
| Figure 15. | WLCSP36 - Outline                                      | 41  |
| Figure 16. | WLCSP36 - Footprint example                            | 42  |
| Figure 17. | WLCSP36 marking example (package top view)             | 43  |



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DS14620 - Rev 2 page 52/52